**PRODUCT SPECIFICATION** 



Integrated Circuits Group<sup>U.com</sup>

# **LH28F160BJHE-BTLTH** Flash Memory 16Mbit (1Mbitx16 / 2Mbitx8)

(Model Number: LHF16JTH)

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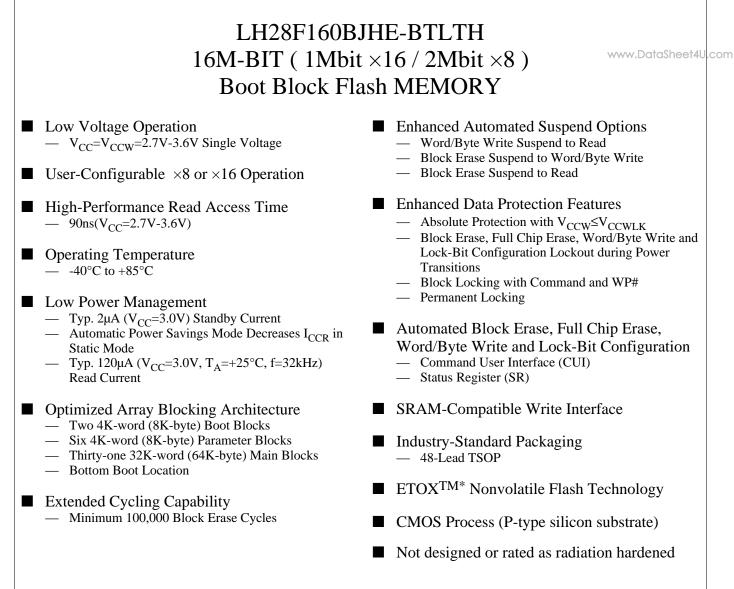
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SHARP's LH28F160BJHE-BTLTH Flash memory is a high-density, low-cost, nonvolatile, read/write storage solution for a wide range of applications.

LH28F160BJHE-BTLTH can operate at  $V_{CC}$ =2.7V-3.6V and  $V_{CCW}$ =2.7V-3.6V or 11.7V-12.3V. Its low voltage operation capability realize battery life and suits for cellular phone application.

Its Boot, Parameter and Main-blocked architecture, low voltage and extended cycling provide for highly flexible component suitable for portable terminals and personal computers. Its enhanced suspend capabilities provide for an ideal solution for code + data storage applications.

For secure code storage applications, such as networking, where code is either directly executed out of flash or downloaded to DRAM, the LH28F160BJHE-BTLTH offers four levels of protection: absolute protection with  $V_{CCW} \leq V_{CCWLK}$ , selective hardware block locking or flexible software block locking. These alternatives give designers ultimate control of their code security needs.

The LH28F160BJHE-BTLTH is manufactured on SHARP's 0.25µm ETOX<sup>TM\*</sup> process technology. It come in industrystandard package: the 48-lead TSOP, ideal for board constrained applications.

\*ETOX is a trademark of Intel Corporation.

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### 1 INTRODUCTION

This datasheet contains LH28F160BJHE-BTLTH specifications. Section 1 provides a flash memory overview. Sections 2, 3, 4 and 5 describe the memory organization and functionality. Section 6 covers electrical specifications.

#### 1.1 Features

Key enhancements of LH28F160BJHE-BTLTH boot block Flash memory are:

- •Single low voltage operation
- •Low power consumption
- •Enhanced Suspend Capabilities
- Boot Block Architecture

Please note following:

•V<sub>CCWLK</sub> has been lowered to 1.0V to support 2.7V-3.6V block erase, full chip erase, word/byte write and lock-bit configuration operations. The V<sub>CCW</sub> voltage transitions to GND is recommended for designs that switch V<sub>CCW</sub> off during read operation.

#### 1.2 Product Overview

The LH28F160BJHE-BTLTH is a high-performance 16Mbit Boot Block Flash memory organized as 1M-word of 16 bits or 2M-byte of 8 bits. The 1M-word/2M-byte of data is arranged in two 4K-word/8K-byte boot blocks, six 4Kword/8K-byte parameter blocks and thirty-one 32Kword/64K-byte main blocks which are individually erasable, lockable and unlockable in-system. The memory map is shown in Figure 3.

The dedicated  $V_{CCW}$  pin gives complete data protection when  $V_{CCW} \leq V_{CCWLK}$ .

A Command User Interface (CUI) serves as the interface between the system processor and internal operation of the device. A valid command sequence written to the CUI initiates device automation. An internal Write State Machine (WSM) automatically executes the algorithms and timings necessary for block erase, full chip erase, word/byte write and lock-bit configuration operations. A block erase operation erases one of the device's 32Kword/64K-byte blocks typically within 1.2s (3V  $V_{CC}$ , 3V  $V_{CCW}$ ), 4K-word/8K-byte blocks typically within 0.6s (3V  $V_{CC}$ , 3V  $V_{CCW}$ ) independent of other blocks. Each block can be independently erased minimum 100,000 times. Block erase suspend mode allows system software to suspend block erase to read or write data from any other block.

Writing memory data is performed in word/byte increments of the device's 32K-word blocks typically within 33 $\mu$ s (3V V<sub>CC</sub>, 3V V<sub>CCW</sub>), 64K-byte blocks typically within 31 $\mu$ s (3V V<sub>CC</sub>, 3V V<sub>CCW</sub>), 4K-word blocks typically within 36 $\mu$ s (3V V<sub>CC</sub>, 3V V<sub>CCW</sub>), 8K-byte blocks typically within 32 $\mu$ s (3V V<sub>CC</sub>, 3V V<sub>CCW</sub>). Word/byte write suspend mode enables the system to read data or execute code from any other flash memory array location.

Individual block locking uses a combination of bits, thirtynine block lock-bits, a permanent lock-bit and WP# pin, to lock and unlock blocks. Block lock-bits gate block erase, full chip erase and word/byte write operations, while the permanent lock-bit gates block lock-bit modification and locked block alternation. Lock-bit configuration operations (Set Block Lock-Bit, Set Permanent Lock-Bit and Clear Block Lock-Bits commands) set and cleared lock-bits.

The status register indicates when the WSM's block erase, full chip erase, word/byte write or lock-bit configuration operation is finished.

The RY/BY# output gives an additional indicator of WSM activity by providing both a hardware signal of status (versus software polling) and status masking (interrupt masking for background block erase, for example). Status polling using RY/BY# minimizes both CPU overhead and system power consumption. When low, RY/BY# indicates that the WSM is performing a block erase, full chip erase, word/byte write or lock-bit configuration. RY/BY#-high Z indicates that the WSM is ready for a new command, block erase is suspended (and word/byte write is inactive), word/byte write is suspended, or the device is in reset mode.

The access time is 90ns ( $t_{AVQV}$ ) over the operating temperature range (-40°C to +85°C) and  $V_{CC}$  supply voltage range of 2.7V-3.6V.

The Automatic Power Savings (APS) feature substantially reduces active current when the device is in static mode (addresses not switching). In APS mode, the typical  $I_{CCR}$  current is 2µA (CMOS) at 3.0V  $V_{CC}$ .

When CE# and RP# pins are at  $V_{CC}$ , the  $I_{CC}$  CMOS standby mode is enabled. When the RP# pin is at GND, reset mode is enabled which minimizes power consumption and provides write protection. A reset time  $(t_{PHQV})$  is required from RP# switching high until outputs are valid. Likewise, the device has a wake time  $(t_{PHEL})$  from RP#-high until writes to the CUI are recognized. With RP# at GND, the WSM is reset and the status register is cleared.

Please do not execute reprogramming "0" for the bit which has already been programed "0". Overwrite operation may generate unerasable bit. In case of reprogramming "0" to the data which has been programed "1".

•Program "0" for the bit in which you want to change data from "1" to "0".

•Program "1" for the bit which has already been programmed "0".

For example, changing data from "10111101" to "10111100" requires "1111110" programming.

1.3 Product Description

1.3.1 Package Pinout

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LH28F160BJHE-BTLTH Boot Block Flash memory is available in 48-lead TSOP package (see Figure 2).

#### 1.3.2 Block Organization

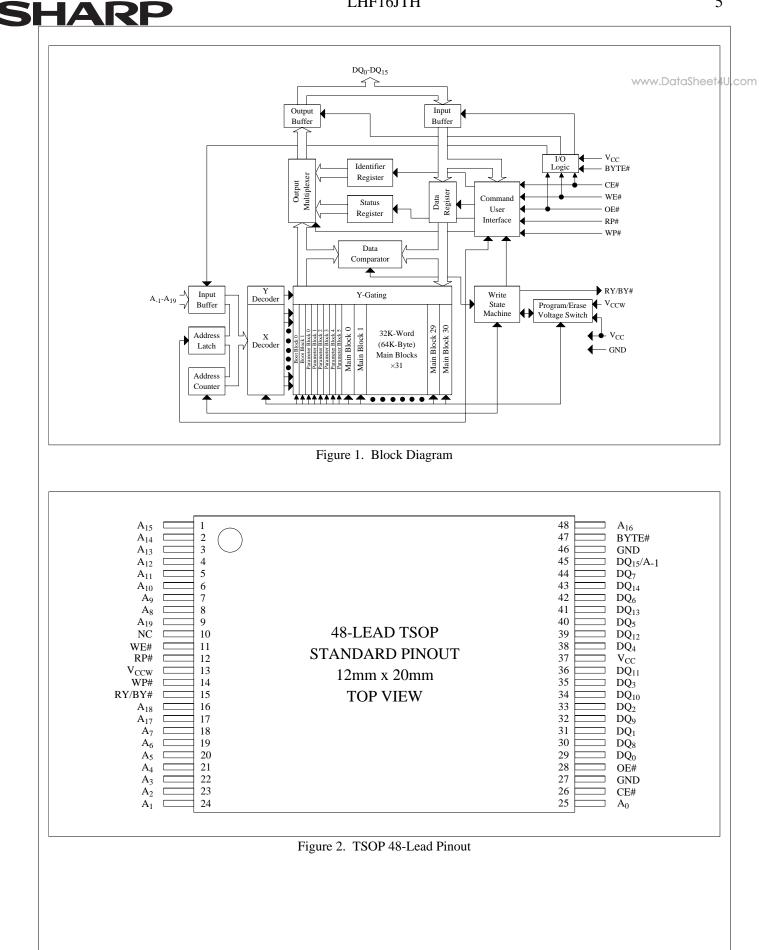
This product features an asymmetrically-blocked architecture providing system memory integration. Each erase block can be erased independently of the others up to 100,000 times. For the address locations of the blocks, see the memory map in Figure 3.

Boot Blocks: The boot block is intended to replace a dedicated boot PROM in a microprocessor or microcontroller-based system. This boot block 4K words (4,096words) features hardware controllable write-protection to protect the crucial microprocessor boot code from accidental modification. The protection of the boot block is controlled using a combination of the V<sub>CCW</sub>, RP#, WP# pins and block lock-bit.

Parameter Blocks: The boot block architecture includes parameter blocks to facilitate storage of frequently update small parameters that would normally require an EEPROM. By using software techniques, the word-rewrite functionality of EEPROMs can be emulated. Each boot block component contains six parameter blocks of 4K words (4,096 words) each. The protection of the parameter block is controlled using a combination of the V<sub>CCW</sub>, RP# and block lock-bit.

Main Blocks: The reminder is divided into main blocks for data or code storage. Each 16M-bit device contains thirtyone 32K words (32,768 words) blocks. The protection of the main block is controlled using a combination of the  $V_{CCW}$ , RP# and block lock-bit.

### LHF16JTH



LHF16JTH

Symbol	Туре	Name and Function
A <sub>-1</sub> A <sub>0</sub> -A <sub>19</sub>	INPUT	ADDRESS INPUTS: Inputs for addresses during read and write operations. Addresses are internally latched during a write cycle. $A_{-1}$ : Lower address input while BYTE# is $V_{IL}$ . $A_{-1}$ pin changes DQ <sub>15</sub> pin while BYTE# is $V_{IH}$ . $A_{15}$ - $A_{19}$ : Main Block Address. $A_{12}$ - $A_{19}$ : Boot and Parameter Block Address.
DQ <sub>0</sub> -DQ <sub>15</sub>	INPUT/ OUTPUT	DATA INPUT/OUTPUTS: Inputs data and commands during CUI write cycles; outputs data during memory array, status register and identifier code read cycles. Data pins float to high-impedance when the chip is deselected or outputs are disabled. Data is internally latched during a write cycle. $DQ_8$ - $DQ_{15}$ pins are not used while byte mode (BYTE#= $V_{IL}$ ). Then, $DQ_{15}$ pin changes $A_{-1}$ address input.
CE#	INPUT	CHIP ENABLE: Activates the device's control logic, input buffers, decoders and sense amplifiers. CE#-high deselects the device and reduces power consumption to standby levels.
RP#	INPUT	RESET: Resets the device internal automation. RP#-high enables normal operation. When driven low, RP# inhibits write operations which provides data protection during power transitions. Exit from reset mode sets the device to read array mode. RP# must be $V_{IL}$ during power-up.
OE#	INPUT	OUTPUT ENABLE: Gates the device's outputs during a read cycle.
WE#	INPUT	WRITE ENABLE: Controls writes to the CUI and array blocks. Addresses and data are latched on the rising edge of the WE# pulse.
WP#	INPUT	WRITE PROTECT: When WP# is $V_{IL}$ , boot blocks cannot be written or erased. When WP# is $V_{IH}$ , locked boot blocks can not be written or erased. WP# is not affected parameter and main blocks.
BYTE#	INPUT	BYTE ENABLE: BYTE# $V_{IL}$ places device in byte mode (×8). All data is then input or output on $DQ_{0-7}$ , and $DQ_{8-15}$ float. BYTE# $V_{IH}$ places the device in word mode (×16), and turns off the $A_{-1}$ input buffer.
RY/BY#	OPEN DRAIN OUTPUT	READY/BUSY#: Indicates the status of the internal WSM. When low, the WSM is performing an internal operation (block erase, full chip erase, word/byte write or lock-bit configuration). RY/BY#-high Z indicates that the WSM is ready for new commands, block erase is suspended, and word/byte write is inactive, word/byte write is suspended, or the device is in reset mode.
V <sub>CCW</sub>	SUPPLY	BLOCK ERASE, FULL CHIP ERASE, WORD/BYTE WRITE OR LOCK-BIT CONFIGURATION POWER SUPPLY: For erasing array blocks, writing words/bytes or configuring lock-bits. With $V_{CCW} \leq V_{CCWLK}$ , memory contents cannot be altered. Block erase, full chip erase, word/byte write and lock-bit configuration with an invalid $V_{CCW}$ (see 6.2.3 DC Characteristics) produce spurious results and should not be attempted. Applying 12V±0.3V to $V_{CCW}$ during erase/write can only be done for a maximum of 1000 cycles on each block. $V_{CCW}$ may be connected to 12V±0.3V for a total of 80 hours maximum.
V <sub>CC</sub>	SUPPLY	DEVICE POWER SUPPLY: Do not float any power pins. With $V_{CC} \leq V_{LKO}$ , all write attempts to the flash memory are inhibited. Device operations at invalid $V_{CC}$ voltage (see 6.2.3 DC Characteristics) produce spurious results and should not be attempted.
GND	SUPPLY	GROUND: Do not float any ground pins.
NC		NO CONNECT: Lead is not internal connected; it may be driven or floated.

### 2 PRINCIPLES OF OPERATION

The LH28F160BJHE-BTLTH flash memory includes an on-chip WSM to manage block erase, full chip erase, word/byte write and lock-bit configuration functions. It allows for: 100% TTL-level control inputs, fixed power supplies during block erase, full chip erase, word/byte write and lock-bit configuration, and minimal processor overhead with RAM-like interface timings.

After initial device power-up or return from reset mode (see section 3 Bus Operations), the device defaults to read array mode. Manipulation of external memory control pins allow array read, standby and output disable operations.

Status register and identifier codes can be accessed through the CUI independent of the V<sub>CCW</sub> voltage. High voltage on V<sub>CCW</sub> enables successful block erase, full chip erase, word/byte write and lock-bit configurations. All functions associated with altering memory contents–block erase, full chip erase, word/byte write, lock-bit configuration, status and identifier codes–are accessed via the CUI and verified through the status register.

Commands are written using standard microprocessor write timings. The CUI contents serve as input to the WSM, which controls the block erase, full chip erase, word/byte write and lock-bit configuration. The internal algorithms are regulated by the WSM, including pulse repetition, internal verification and margining of data. Addresses and data are internally latched during write cycles. Writing the appropriate command outputs array data, accesses the identifier codes or outputs status register data.

Interface software that initiates and polls progress of block erase, full chip erase, word/byte write and lock-bit configuration can be stored in any block. This code is copied to and executed from system RAM during flash memory updates. After successful completion, reads are again possible via the Read Array command. Block erase suspend allows system software to suspend a block erase to read/write data from/to blocks other than that which is suspend. Word/byte write suspend allows system software to suspend a word/byte write to read data from any other flash memory array location.

FFFFF         32KW/64KB Main Block         30           FFFFF         32KW/64KB Main Block         29           EFFFF         32KW/64KB Main Block         28           DFFFF         32KW/64KB Main Block         27           DFFFF         32KW/64KB Main Block         26           DFFFF         32KW/64KB Main Block         25           DFFFF         32KW/64KB Main Block         23           DFFFF         32KW/64KB Main Block         21           DFFFF         32KW/64KB Main Block         21           DFFFF         32KW/64KB Main Block         20           DFFFF         32KW/64KB Main Block         19           DFFFF         32KW/64KB Main Block         18           DFFFF         32KW/64KB Main Block         18           DFFFF         32KW/64KB Main Block         13           DFFFF         32KW/64KB Main Block         13           DFFFF         32KW/64KB Main Block         11           DFFFF         32KW/64KB Main Block         10           DFFFF	[A <sub>19</sub> -A <sub>0</sub> ]	Bottom Boot	~~~~	Autosheet40.com
FYFFF         32KW/64KB Main Block         29         EE0000           E0000         DOFFFF         32KW/64KB Main Block         28         DD0000           D0000         DOFFFF         32KW/64KB Main Block         27         ICC000           D0000         DOFFFF         32KW/64KB Main Block         26         B0000           D0000         CO000         DOFFFF         32KW/64KB Main Block         23           D0000         CO000         B0000         IAFFFF         32KW/64KB Main Block         23           B0000         B0000         CO000         B0000         IAFFFF         32KW/64KB Main Block         21           B0000         B0000         IAFFFF         32KW/64KB Main Block         10         IAFFFF           B0000         A7000         TFFFF         32KW/64KB Main Block         18         IAFFFF           B0000         A2KW/64KB Main Block         17         IAFFFF         IAFFFF         IAFFFF           S0000         A2KW/64KB Main Block         16         IAFFFF         IAFFFF           S0000         IAFFFF         IAFFFF         IAFFFF         IAFFFF           S0000         IAFFFF         IAFFFF         IAFFFF         IAFFFF           S0000 <td></td> <td>32KW/64KB Main Block</td> <td>30</td> <td></td>		32KW/64KB Main Block	30	
EFFFF         32KW/64KB Main Block         28         DD0000           E0000         D00001         ICPFFF         ICPFFF           B0000         D00001         ICPFFF         ICPFFF           B0000         D00000         ICPFFF         ICPFFF           B0000         CO000         IBFFFF         IBFFFF           D0000         CO000         ISFFFF         IAFFFF           C0000         B00000         ISFFFF         ISFFFF           B0000         ISFFFF         ISCM/64KB Main Block         21           B0000         ISFFFF         ISCM/64KB Main Block         20           ISFFFF         ISCM/64KB Main Block         19           ISFFFF         ISCM/64KB Main Block         19           ISFFFF         ISCM/64KB Main Block         10           ISFFFF         ISCM/64KB Main Block <t< td=""><td>F7FFF</td><td>32KW/64KB Main Block</td><td>29</td><td>1EFFFF</td></t<>	F7FFF	32KW/64KB Main Block	29	1EFFFF
E7FFF         32KW/64KB Main Block         27         ICCFFFF           B0000         32KW/64KB Main Block         26         B0000           D00000         32KW/64KB Main Block         25         A0000           CFFFF         32KW/64KB Main Block         24         100000           CC0007         32KW/64KB Main Block         23         1887FFF           B00000         1387FFF         32KW/64KB Main Block         21         100000           B00000         1387FFF         32KW/64KB Main Block         21         100000           B00000         32KW/64KB Main Block         20         155700         149700           A0000         32KW/64KB Main Block         19         149707         149700         149707           A0000         32KW/64KB Main Block         17         120000         110700         110700           90000         32KW/64KB Main Block         14         67000         110707         110700           90000         32KW/64KB Main Block         10         110700         110700         110700           90000         32KW/64KB Main Block         10         067000         06777         070000           90000         32KW/64KB Main Block         10         06777	EFFFF	32KW/64KB Main Block	28	1DFFFF
DFFFF D8000 20000         32KW/64KB Main Block         26 20000           32KW/64KB Main Block         25 32KW/64KB Main Block         10000           32KW/64KB Main Block         24 90000         10000           32KW/64KB Main Block         21 90000         10000           B8000         32KW/64KB Main Block         21 10000           B8000         32KW/64KB Main Block         21 10000           B8000         32KW/64KB Main Block         21 10000           A8000         32KW/64KB Main Block         10 10000           A8000         32KW/64KB Main Block         10 10000           A8000         32KW/64KB Main Block         10 10000           90000         32KW/64KB Main Block         10 10000           90000         32KW/64KB Main Block         10 10000           90000         32KW/64KB Main Block         10 00000           90000         32KW/64KB Main Block         10 000000	E7FFF	32KW/64KB Main Block	27	1CFFFF
D7FFF D0000 (C)         32KW/64KB Main Block         25 (1)           32KW/64KB Main Block         24 (1)           32KW/64KB Main Block         23 (1)           B0000 BFFF         32KW/64KB Main Block         21 (1)           32KW/64KB Main Block         21 (1)           AG000 ATFFF         32KW/64KB Main Block         10 (1)           AG000 ATFFF         32KW/64KB Main Block         19 (1)           ATFFF         32KW/64KB Main Block         19 (1)           ATFFF         32KW/64KB Main Block         17 (1)           90000 90FFF         32KW/64KB Main Block         18 (1)           90000 90FFF         32KW/64KB Main Block         16 (1)           90000 90FFFF         32KW/64KB Main Block         16 (1)           90000 90FFFF         32KW/64KB Main Block         10           90000 90FFF         32KW/64KB Main Block         0           90000 90FFF         32KW/64KB Main Block         0           90000 90FFF         32KW/64KB Main Block         0           900000 90FFF         32KW/64KB Main Block <td>DFFFF</td> <td>32KW/64KB Main Block</td> <td>26</td> <td>1BFFFF</td>	DFFFF	32KW/64KB Main Block	26	1BFFFF
CCFFFF $32KW/64KB$ Main Block         24         19FFFF           00000         32KW/64KB Main Block         23           B8000         32KW/64KB Main Block         21           B8000         32KW/64KB Main Block         21           A0000         32KW/64KB Main Block         20           A0000         32KW/64KB Main Block         10           A0000         32KW/64KB Main Block         19           A0000         32KW/64KB Main Block         18           130000         13FFFF         15000           97FFF         32KW/64KB Main Block         17           120000         12FFFF         100000           97FFF         32KW/64KB Main Block         16           110000         11         11           97FFF         32KW/64KB Main Block         17           120000         77FFF         100000           77FFF         32KW/64KB Main Block         10           97FFF         32KW/64KB Main Block         00           97FFF         32KW/64KB Main Blo	D7FFF	32KW/64KB Main Block	25	1AFFFF
C7FFF $32KW/64KB$ Main Block         23           BBFFFF $32KW/64KB$ Main Block         22           BBFFFF $32KW/64KB$ Main Block         21           AFFFF $32KW/64KB$ Main Block         20           AFFFF $32KW/64KB$ Main Block         19           AFFFF $32KW/64KB$ Main Block         19           AFFFF $32KW/64KB$ Main Block         18 $30000$ $32KW/64KB$ Main Block         18 $30000$ $32KW/64KB$ Main Block         17 $30000$ $32KW/64KB$ Main Block         16 $30000$ $32KW/64KB$ Main Block         10 $32KW/64KB$ Main Block         14         00000 $7FFF$ $32KW/64KB$ Main Block         13 $70000$ $60000$ $00FFFF$ $32KW/64KB$ Main Block         10 $7FFF$ $32KW/64KB$ Main Block         0 $32KW/64KB$ Main Block         0 $7FFF$ $32KW/64KB$ Main Block         0 $32KW/64KB$ Main Block         0 $7FFF$ $32KW/64KB$ Main Block         0 $7FFF$ $32KW/64KB$ Main Block <td>CFFFF</td> <td>32KW/64KB Main Block</td> <td>24</td> <td>19FFFF</td>	CFFFF	32KW/64KB Main Block	24	19FFFF
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B7FFF $32KW/64KB$ Main Block $21$ $16FFFF$ A3000 $32KW/64KB$ Main Block $20$ $150000$ AAFFF $32KW/64KB$ Main Block $19$ $140000$ $32KW/64KB$ Main Block $18$ $130000$ $137FFF$ $90000$ $92FFF$ $32KW/64KB$ Main Block $18$ $90000$ $32KW/64KB$ Main Block $16$ $97FFF$ $32KW/64KB$ Main Block $15$ $90000$ $32KW/64KB$ Main Block $16$ $87FFF$ $32KW/64KB$ Main Block $16$ $70000$ $17FFF$ $32KW/64KB$ Main Block $10$ $70000$ $6FFFF$ $32KW/64KB$ Main Block $10$ $70000$ $32KW/64KB$ Main Block $10$ $00000$ $7FFF$ $32KW/64KB$ Main Block $0$ $00000$ $7FFF$ $32KW/64KB$ Main Block $0$ $00000$ $47FFF$ $32KW/64KB$ Main Block $0$ $00000$ $47FFF$ $32KW/64KB$ Main Block $0$ $00000$ $30000$ $32KW/64$	BFFFF	32KW/64KB Main Block	22	17FFFF
AFFFF $32KW/64KB$ Main Block $20$ ISFFFF           A0000 $32KW/64KB$ Main Block         19         140001           9FFFF $32KW/64KB$ Main Block         18         130000           9FFFF $32KW/64KB$ Main Block         17         120000           9FFFF $32KW/64KB$ Main Block         16         110000           8FFFF $32KW/64KB$ Main Block         16         110000           8FFFF $32KW/64KB$ Main Block         14         0FFFF           90000 $32KW/64KB$ Main Block         14         0F0000           7FFF $32KW/64KB$ Main Block         13         0EFFFF           700000 $32KW/64KB$ Main Block         10         00000           7FFF $32KW/64KB$ Main Block         10         050000           0FFFF $32KW/64KB$ Main Block         10         050000           9FFFF $32KW/64KB$ Main Block         9         0A0000           9FFFF $32KW/64KB$ Main Block         9         0A0000           9FFFF $32KW/64KB$ Main Block         0         050000           900000 $3FFFF$ $32KW/64KB$ Main Block         0         050000 <t< td=""><td>B7FFF</td><td>32KW/64KB Main Block</td><td>21</td><td>16FFFF</td></t<>	B7FFF	32KW/64KB Main Block	21	16FFFF
A7FFF $32KW/64KB$ Main Block       19       14FFFF         98000 $32KW/64KB$ Main Block       18       130000         97FFF $32KW/64KB$ Main Block       17       120000         98000 $32KW/64KB$ Main Block       16       100000         88000 $32KW/64KB$ Main Block       16       100000         87FFF $32KW/64KB$ Main Block       15       100000         78000 $32KW/64KB$ Main Block       13       0FFFF         78000 $32KW/64KB$ Main Block       12       0F0000         78000 $32KW/64KB$ Main Block       12       0F0000         78000 $32KW/64KB$ Main Block       10       0EFFFF         68000 $32KW/64KB$ Main Block       0       0FFFF         50000 $32KW/64KB$ Main Block       0       0FFFF         50000 $32KW/64KB$ Main Block       0       08FFFF         30000 $37FFF$ $32KW/64KB$ Main Block       0       08FFFF         30000 $37FFF$ $32KW/64KB$ Main Block       0       05FFFF         30000 $37FFF$ $32KW/64KB$ Main Block       0       05FFFF         30000 $37FFF$ $32KW/64KB$ Main Block	AFFFF	32KW/64KB Main Block	20	15FFFF
9FFFF $32KW/64KB$ Main Block         18         13FFFF           90000 $32KW/64KB$ Main Block         17         120000           8FFFF $32KW/64KB$ Main Block         16         110000           8FFFF $32KW/64KB$ Main Block         16         110000           8FFFF $32KW/64KB$ Main Block         15         100000           7FFF $32KW/64KB$ Main Block         14         0F0000           7FFF $32KW/64KB$ Main Block         13         0EFFFF           700000 $32KW/64KB$ Main Block         11         0F0000           7FFF $32KW/64KB$ Main Block         10         0BFFFF           60000 $6FFFF$ $32KW/64KB$ Main Block         10         0BFFFF           50000 $32KW/64KB$ Main Block         10         0BFFFF         00000           4FFF $32KW/64KB$ Main Block         9         90000         0AFFFF           30000 $32KW/64KB$ Main Block         7         88000         0FFFF           30000 $32KW/64KB$ Main Block         0         0FFFF         07000           30000 $32KW/64KB$ Main Block         0         05FFFF         0           30000	A7FFF	32KW/64KB Main Block	19	14FFFF
97FFF         32KW/64KB Main Block         17           90000         32KW/64KB Main Block         16           88000         32KW/64KB Main Block         16           87FFF         32KW/64KB Main Block         15           90000         77FF         32KW/64KB Main Block         14           70000         77FFF         32KW/64KB Main Block         14           70000         6FFFF         32KW/64KB Main Block         12           70000         0FFFF         32KW/64KB Main Block         10           70000         5FFFF         32KW/64KB Main Block         10           667FF         32KW/64KB Main Block         10           70000         5FFFF         32KW/64KB Main Block         90000           97FFF         32KW/64KB Main Block         90000           48000         37FFF         32KW/64KB Main Block         90000           37FFF         32KW/64KB Main Block         900000         97FFF           38000         32KW/64KB Main Block         900000         97FFF           30000         37FFF         32KW/64KB Main Block         900000           97FFF         32KW/64KB Main Block         900000           97FFF         32KW/64KB Main Block         900000 </td <td>9FFFF</td> <td>32KW/64KB Main Block</td> <td>18</td> <td>13FFFF</td>	9FFFF	32KW/64KB Main Block	18	13FFFF
SFFFF $32KW/64KB$ Main Block         16         11FFFF           80000 $32KW/64KB$ Main Block         15         100000           7FFFF $32KW/64KB$ Main Block         14           78000 $32KW/64KB$ Main Block         14           78000 $32KW/64KB$ Main Block         13           68000 $7FFF$ $32KW/64KB$ Main Block         12           68000 $6FFFF$ $32KW/64KB$ Main Block         10           68000 $32KW/64KB$ Main Block         10 $00FFFF$ $58000$ $32KW/64KB$ Main Block         10 $00FFFF$ $58000$ $32KW/64KB$ Main Block         9 $00FFFF$ $32KW/64KB$ Main Block         9 $00FFFF$ $00000$ $4FFFF$ $32KW/64KB$ Main Block         9 $00000$ $37FFF$ $32KW/64KB$ Main Block         9 $00000$ $2FFFF$ $32KW/64KB$ Main Block         9 $00000$ $2FFFF$ $32KW/64KB$ Main Block         9 $00000$ $2FFFF$ $32KW/64KB$ Main Block         9 $00000$ $0FFFF$ $32KW/64KB$ Main Block		32KW/64KB Main Block	17	12FFFF
87FFF $32KW/64KB$ Main Block         15         10FFFF           78000 $32KW/64KB$ Main Block         14         0F0000           77FFF $32KW/64KB$ Main Block         13         0F0000           66000 $32KW/64KB$ Main Block         12         0F0000           67FFF $32KW/64KB$ Main Block         12         0F0000           66000 $32KW/64KB$ Main Block         10         0EFFFF           60000 $57FFF$ $32KW/64KB$ Main Block         10         0BFFFF           50000 $32KW/64KB$ Main Block         10         0BFFFF         0B0000 $57FFF$ $32KW/64KB$ Main Block         9         0A0000         0FFFF $50000$ $4FFF$ $32KW/64KB$ Main Block         090000         07FFFF $38000$ $32KW/64KB$ Main Block         7         080000         07FFFF $38000$ $22KW/64KB$ Main Block         070000         04FFFF $30000$ $22KW/64KB$ Main Block         030000         04FFFF $30000$ $27FFF$ $32KW/64KB$ Main Block         030000         04FFFF $30000$ $02FFF$ $32KW/64KB$ Main Block         <	8FFFF	32KW/64KB Main Block	16	11FFFF
7FFFF $32KW/64KB$ Main Block         14         0FFFFF           78000 $32KW/64KB$ Main Block         13         0FFFFF           70000 $32KW/64KB$ Main Block         12         0D0000           66000 $32KW/64KB$ Main Block         12         0D0000           67000 $32KW/64KB$ Main Block         11         0C0000           67000 $32KW/64KB$ Main Block         10         0B0000           57FFF $32KW/64KB$ Main Block         10         0B0000           57FFF $32KW/64KB$ Main Block         9         0A0000           48000 $4KW/64KB$ Main Block         9         0A0000           4FFFF $32KW/64KB$ Main Block         7         080000           37FFF $32KW/64KB$ Main Block         7         080000           37FFF $32KW/64KB$ Main Block         050000         0FFFF           30000 $32KW/64KB$ Main Block         050000         04FFFF           20000 $32KW/64KB$ Main Block         050000         04FFFF           20000 $32KW/64KB$ Main Block         030000         02FFFF           30000 $32KW/64KB$ Main Block         0000FFF         040000	87FFF	32KW/64KB Main Block	15	10FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	7FFFF	32KW/64KB Main Block	14	0FFFFF
6FFFF $32KW/64KB$ Main Block $12$ 0DFFFF           60000 $32KW/64KB$ Main Block $11$ 0C00FFF $60000$ $32KW/64KB$ Main Block $10$ $0B0000$ $5FFF$ $32KW/64KB$ Main Block $10$ $0B0000$ $57FFF$ $32KW/64KB$ Main Block $9$ $0A0000$ $4FFFF$ $32KW/64KB$ Main Block $9$ $0A0000$ $4FFFF$ $32KW/64KB$ Main Block $7$ $080000$ $4FFFF$ $32KW/64KB$ Main Block $7$ $080000$ $3FFFF$ $32KW/64KB$ Main Block $7$ $080000$ $3FFFF$ $32KW/64KB$ Main Block $7$ $080000$ $2FFFF$ $32KW/64KB$ Main Block $0$ $06FFF$ $28000$ $22KW/64KB$ Main Block $3$ $040000$ $2FFFF$ $32KW/64KB$ Main Block $3$ $030000$ $0FFFF$ $32KW/64KB$ Main Block $3$ $00000$ $0FFFF$ $32KW/64KB$ Main Block $3$ $00000$ $0FFFF$ $32KW/64KB$ Main Block <td< td=""><td>77FFF</td><td>32KW/64KB Main Block</td><td>13</td><td>0EFFFF</td></td<>	77FFF	32KW/64KB Main Block	13	0EFFFF
67FFF 60000 $32KW/64KB$ Main Block         11         0CFFFF 0C0000           5FFFF $32KW/64KB$ Main Block         10         0BFFF           58000 $32KW/64KB$ Main Block         9         0A0000           4FFFF $32KW/64KB$ Main Block         9         0A0000           4FFFF $32KW/64KB$ Main Block         9         090000           4FFFF $32KW/64KB$ Main Block         7         080000 $3FFFF$ $32KW/64KB$ Main Block         7         080000 $3FFFF$ $32KW/64KB$ Main Block         6         070000 $3FFFF$ $32KW/64KB$ Main Block         0         06FFFF $30000$ $2FFFF$ $32KW/64KB$ Main Block         0         05FFFF $20000$ $2FFFF$ $32KW/64KB$ Main Block         0         040000 $2FFFF$ $32KW/64KB$ Main Block         0         00000         03FFFF $10000$ 0FFFF $32KW/64KB$ Main Block         0         00000         01FFF $10000$ 0FFFF $32KW/64KB$ Main Block         0         00000         01FFF $100000$ 0FFFF $32KW/64KB$ Parameter Block <td>6FFFF</td> <td>32KW/64KB Main Block</td> <td>12</td> <td>0DFFFF</td>	6FFFF	32KW/64KB Main Block	12	0DFFFF
SFFFF $32KW/64KB$ Main Block       10       0BFFFF         50000 $32KW/64KB$ Main Block       9 $0A000$ 40000 $32KW/64KB$ Main Block       9 $0A0000$ 40000 $32KW/64KB$ Main Block       8 $090000$ $4FFFF$ $32KW/64KB$ Main Block       7 $080000$ $3FFFF$ $32KW/64KB$ Main Block       7 $080000$ $3FFFF$ $32KW/64KB$ Main Block       6 $0700000$ $3TFFF$ $32KW/64KB$ Main Block       7 $080000$ $3TFFF$ $32KW/64KB$ Main Block       0 $05FFFF$ $20000$ $3TFFF$ $32KW/64KB$ Main Block       0 $050000$ $2TFFF$ $32KW/64KB$ Main Block       0 $050000$ $04FFF$ $20000$ $3TFFF$ $32KW/64KB$ Main Block       0 $00000$ $1FFFF$ $32KW/64KB$ Main Block       10 $00000$ $02FFFF$ $00000$ $07FFF$ $32KW/64KB$ Main Block       0 $00000$ $07FFF$ $32KW/64KB$ Main Block       0 $00000$ $00FFF$ $00000$ $07FFF$ $00C000$ $0$	67FFF	32KW/64KB Main Block	11	0CFFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	5FFFF	32KW/64KB Main Block	10	OBFFFF
4FFFF 48000 $32KW/64KB$ Main Block $8$ 09FFFF 090000 $47FFF$ $32KW/64KB$ Main Block $7$ $98000$ $3FFFF$ $32KW/64KB$ Main Block $7$ $98000$ $37FFF$ $32KW/64KB$ Main Block $6$ $770000$ $37FFF$ $32KW/64KB$ Main Block $6$ $06000$ $2FFFF$ $32KW/64KB$ Main Block $4$ $050000$ $2FFFF$ $32KW/64KB$ Main Block $4$ $050000$ $27FFF$ $32KW/64KB$ Main Block $040000$ $03FFFF$ $20000$ $17FFF$ $32KW/64KB$ Main Block $040000$ $03FFFF$ $10000$ $0FFFF$ $32KW/64KB$ Main Block $00000$ $03FFFF$ $17FFF$ $32KW/64KB$ Main Block $010000$ $00FFFF$ $030000$ $0FFFF$ $32KW/64KB$ Main Block $00000$ $00FFFF$ $00000$ $00FFF$ $4KW/8KB$ Parameter Block $000000$ $00FFF$ $000000$ $00FFF$ $4KW/8KB$ Parameter Block $000000$ $000FFF$ $008000$ $007FFF$ $000000$ $00FFF$ $4KW/8KB$ Parameter Block	57FFF	32KW/64KB Main Block	9	0AFFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	4FFFF	32KW/64KB Main Block	8	09FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	47FFF	32KW/64KB Main Block	7	08FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	3FFFF	32KW/64KB Main Block	6	07FFFF
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	37FFF	32KW/64KB Main Block	5	06FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		32KW/64KB Main Block	4	05FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		32KW/64KB Main Block	3	04FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	1FFFF	32KW/64KB Main Block	2	03FFFF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	17FFF	32KW/64KB Main Block	1	
$\begin{array}{c cccc} 07FFF \\ 07000 \\ 06FFF \\ 06000 \\ 05FFF \\ 06000 \\ 05FFF \\ 05000 \\ 04FFF \\ 04000 \\ 03FFF \\ 04000 \\ 00FFF \\ 00000 \\ 000FFF \\ 00000 \\ 00FFF \\ 00000 \\ 000FFF \\ 0000 \\ 000FFF \\ 00000 \\ 000FFF \\ 0000 \\ 00$		32KW/64KB Main Block	0	
06FFF 06000         4KW/8KB Parameter Block         00DFFF 00C000           05FFF         4KW/8KB Parameter Block         00BFFF           04000         4KW/8KB Parameter Block         008000           04FFF         4KW/8KB Parameter Block         008000           03FFF         4KW/8KB Parameter Block         008000           03FFF         4KW/8KB Parameter Block         006000           02FFF         4KW/8KB Parameter Block         006000           02FFF         0005FFF         004000           01FFF         4KW/8KB Parameter Block         0005FFF           02000         005FFF         002000           00FFF         4KW/8KB Boot Block         002000           00FFF         4KW/8KB Boot Block         002000           00FFF         4KW/8KB Boot Block         002000	07FFF	4KW/8KB Parameter Block	5	00FFFF
05FFF 05000         4KW/8KB Parameter Block         3         00BFFF 00A000           04FFF         4KW/8KB Parameter Block         2         009FFF 009FFF           03000         4KW/8KB Parameter Block         1         005FFF           03000         02FFF         4KW/8KB Parameter Block         0005FFF           02000         01FFF         4KW/8KB Parameter Block         005FFF           02000         01FFF         004000         003FFF           0000         00FFF         004000         003FFF           0000         005FFF         002000         001FFF           00000         001FFF         002000         001FFF	06FFF	4KW/8KB Parameter Block	4	00DFFF
04FFF         4KW/8KB Parameter Block         009FFF           04000         03FFF         4KW/8KB Parameter Block         007FFF           03000         02FFF         4KW/8KB Parameter Block         006000           02FFF         006000         005FFF           02000         4KW/8KB Parameter Block         0005FFF           00000         003FFF         004000           01FFF         4KW/8KB Boot Block         0032000           00FFF         4KW/8KB Boot Block         002000           00FFF         4KW/8KB Boot Block         001FFF	05FFF	4KW/8KB Parameter Block	3	00BFFF
03FFF         4KW/8KB Parameter Block         007FFF           03000         02FFF         006000           02FFF         4KW/8KB Parameter Block         005FFF           02000         01FFF         004000           01FFF         4KW/8KB Boot Block         003FFF           0000         007FFF         002000           000FFF         4KW/8KB Boot Block         002000           001FFF         4KW/8KB Boot Block         002000	04FFF	4KW/8KB Parameter Block	2	009FFF
02FFF         4KW/8KB Parameter Block         005FFF           02000         001FFF         004000           01FFF         4KW/8KB Boot Block         002000           00FFF         4KW/8KB Boot Block         002000           00FFF         4KW/8KB Boot Block         001FFF	03FFF	4KW/8KB Parameter Block	1	007FFF
01FFF 01000 00FFF 4KW/8KB Boot Block 1 003FFF 002000 001FFF 002000 001FFF	02FFF	4KW/8KB Parameter Block	0	005FFF
00FFF 4KW/8KB Boot Block 0 001FFF	01FFF	4KW/8KB Boot Block	1	003FFF
	00FFF	4KW/8KB Boot Block	0	001FFF

Figure 3. Memory Map

#### 2.1 Data Protection

When  $V_{CCW} \le V_{CCWLK}$ , memory contents cannot be altered. The CUI, with two-step block erase, full chip erase, word/byte write or lock-bit configuration command sequences, provides protection from unwanted operations even when high voltage is applied to  $V_{CCW}$ . All write functions are disabled when  $V_{CC}$  is below the write lockout voltage  $V_{LKO}$  or when RP# is at  $V_{IL}$ . The device's block locking capability provides additional protection from inadvertent code or data alteration by gating block erase, full chip erase and word/byte write operations. Refer to Table 5 for write protection alternatives.

#### **3** BUS OPERATION

The local CPU reads and writes flash memory in-system. All bus cycles to or from the flash memory conform to standard microprocessor bus cycles.

#### 3.1 Read

Information can be read from any block, identifier codes or status register independent of the  $V_{CCW}$  voltage. RP# can be at  $V_{IH}$ .

The first task is to write the appropriate read mode command (Read Array, Read Identifier Codes or Read Status Register) to the CUI. Upon initial device power-up or after exit from reset mode, the device automatically resets to read array mode. Six control pins dictate the data flow in and out of the component: CE#, OE#, BYTE#, WE#, RP# and WP#. CE# and OE# must be driven active to obtain data at the outputs. CE# is the device selection control, and when active enables the selected memory device. OE# is the data output (DQ<sub>0</sub>-DQ<sub>15</sub>) control and when active drives the selected memory data onto the I/O bus. BYTE# is the device I/O interface mode control. WE# must be at V<sub>II</sub>, RP# must be at V<sub>IH</sub>, RP# must be at V<sub>II</sub>, figure 14, 15 illustrates read cycle.

#### 3.2 Output Disable

With OE# at a logic-high level (V<sub>IH</sub>), the device outputs are disabled. Output pins (DQ\_0-DQ\_{15}) are placed in a high-impedance state.

#### 3.3 Standby

CE# at a logic-high level  $(V_{IH})$  places the device in standby mode which substantially reduces device power consumption.  $DQ_0$ - $DQ_{15}$  outputs are placed in a highimpedance state independent of OE#. If deselected during block erase, full chip erase, word/byte write or lock-bit configuration, the device continues functioning, and consuming active power until the operation completes.

#### 3.4 Reset

RP# at  $V_{IL}$  initiates the reset mode.

In read modes, RP#-low deselects the memory, places output drivers in a high-impedance state and turns off all internal circuits. RP# must be held low for a minimum of 100ns. Time  $t_{PHQV}$  is required after return from reset mode until initial memory access outputs are valid. After this wake-up interval, normal operation is restored. The CUI is reset to read array mode and status register is set to 80H.

During block erase, full chip erase, word/byte write or lock-bit configuration modes, RP#-low will abort the operation. RY/BY# remains low until the reset operation is complete. Memory contents being altered are no longer valid; the data may be partially erased or written. Time  $t_{PHWL}$  is required after RP# goes to logic-high (V<sub>IH</sub>) before another command can be written.

As with any automated device, it is important to assert RP# during system reset. When the system comes out of reset, it expects to read from the flash memory. Automated flash memories provide status information when accessed during block erase, full chip erase, word/byte write or lock-bit configuration modes. If a CPU reset occurs with no flash memory reset, proper CPU initialization may not occur because the flash memory may be providing status information instead of array data. SHARP's flash memories allow proper CPU initialization following a system reset through the use of the RP# input. In this application, RP# is controlled by the same RESET# signal that resets the system CPU.

L

# SHARP

#### 3.5 Read Identifier Codes

The read identifier codes operation outputs the manufacturer code, device code, block lock configuration codes for each block and the permanent lock configuration code (see Figure 4). Using the manufacturer and device codes, the system CPU can automatically match the device with its proper algorithms. The block lock and permanent lock configuration codes identify locked and unlocked blocks and permanent lock-bit setting.

#### 3.6 Write

Writing commands to the CUI enable reading of device data and identifier codes. They also control inspection and clearing of the status register. When  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ , the CUI additionally controls block erase, full chip erase, word/byte write and lock-bit configuration.

The Block Erase command requires appropriate command data and an address within the block to be erased. The Full Chip Erase command requires appropriate command data and an address within the device. The Word/Byte Write command requires the command and address of the location to be written. Set Permanent and Block Lock-Bit commands require the command and address within the device (Permanent Lock) or block within the device (Block Lock) to be locked. The Clear Block Lock-Bits command requires the command and address within the device.

The CUI does not occupy an addressable memory location. It is written when WE# and CE# are active. The address and data needed to execute a command are latched on the rising edge of WE# or CE# (whichever goes high first). Standard microprocessor write timings are used. Figures 16 and 17 illustrate WE# and CE# controlled write operations.

#### **4 COMMAND DEFINITIONS**

When the V<sub>CCW</sub> voltage  $\leq$ V<sub>CCWLK</sub>, read operations from the status register, identifier codes, or blocks are enabled. Placing V<sub>CCWH1/2</sub> on V<sub>CCW</sub> enables successful block erase, full chip erase, word/byte write and lock-bit configuration operations.

Device operations are selected by writing specific commands into the CUI. Table 3 defines these commands.

	Bottom Boot
[A <sub>19</sub> -A <sub>0</sub> ]*	www.Ddidsneer4
FFFFF	
F8003	Reserved for Future Implementation
F8002	Main Block 30 Lock Configuration Code
F8001	
F8000	Reserved for Future Implementation Main Block 30
F7FFF	
10000	(Main Blocks 1 through 29)
0FFFF	
	Reserved for Future Implementation
08003	
08002	Main Block 0 Lock Configuration Code
08001	Reserved for Future Implementation
08000	Main Block 0
07FFF	
07003	Reserved for Future Implementation
07003	Parameter Block 5 Lock Configuration Code
07002	
07000	Reserved for Future Implementation
06FFF	Parameter Block 5
03000	(Parameter Blocks 1 through 4)
02FFF	
02111	Reserved for Future Implementation
02003	Å
02002	Parameter Block 0 Lock Configuration Code
02001	Reserved for Future Implementation
02000	Parameter Block 0
01FFF	
01000	Reserved for Future Implementation
01003	Boot Block 1 Lock Configuration Code
01002	
01001	Reserved for Future Implementation
01000 00FFF	Boot Block 1
OULLL	Reserved for Future Implementation
00004	
00003	Permanent Lock Configuration Code
00002	Boot Block 0 Lock Configuration Code
00001	Device Code
00000	Manufacturer Code Boot Block 0
L *•	Address A <sub>-1</sub> don't care.
•	

Figure 4. Device Identifier Code Memory Map

Table 2.1. Bus Operations $(BYTE \#=V_{IH})^{(1,2)}$										
Mode	Notes	RP#	CE#	OE#	WE#	Address	V <sub>CCW</sub>	DQ <sub>0-15</sub>	RY/BY# <sup>(3)</sup>	
Read	8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	Х	X	D <sub>OUT</sub>	X	U.COI
Output Disable		V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IH</sub>	Х	X	High Z	Х	
Standby		V <sub>IH</sub>	V <sub>IH</sub>	Х	X	Х	X	High Z	Х	
Reset	4	V <sub>IL</sub>	X	Х	X	Х	X	High Z	High Z	
Read Identifier Codes	8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	See Figure 4	X	Note 5	High Z	
Write	6,7,8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IL</sub>	X	X	D <sub>IN</sub>	X	

#### Table 2.2. Bus Operations (BYTE#= $V_{rr}$ )<sup>(1,2)</sup>

		1 4010 2.2	2. Dus Op	crations (	$DIIL_{ii} = 0$				
Mode	Notes	RP#	CE#	OE#	WE#	Address	V <sub>CCW</sub>	DQ <sub>0-7</sub>	RY/BY# <sup>(3)</sup>
Read	8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	Х	X	D <sub>OUT</sub>	Х
Output Disable		V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IH</sub>	Х	X	High Z	Х
Standby		V <sub>IH</sub>	V <sub>IH</sub>	Х	X	Х	X	High Z	X
Reset	4	V <sub>IL</sub>	X	Х	X	Х	Х	High Z	High Z
Read Identifier Codes	8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	See Figure 4	X	Note 5	High Z
Write	6,7,8	V <sub>IH</sub>	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IL</sub>	Х	X	D <sub>IN</sub>	X

NOTES:

1. Refer to DC Characteristics. When  $V_{CCW} \leq V_{CCWLK}$ , memory contents can be read, but not altered.

2. X can be  $V_{IL}$  or  $V_{IH}$  for control pins and addresses, and  $V_{CCWLK}$  or  $V_{CCWH1/2}$  for  $V_{CCW}$ . See DC Characteristics for V<sub>CCWLK</sub> voltages.

3. RY/BY is  $V_{OL}$  when the WSM is executing internal block erase, full chip erase, word/byte write or lock-bit configuration algorithms. It is High Z during when the WSM is not busy, in block erase suspend mode (with word/byte write inactive), word/byte write suspend mode or reset mode.

4. RP# at GND±0.2V ensures the lowest power consumption.

5. See Section 4.2 for read identifier code data.

6. Command writes involving block erase, full chip erase, word/byte write or lock-bit configuration are reliably executed when  $V_{CCW}=V_{CCWH1/2}$  and  $V_{CC}=2.7V-3.6V$ . 7. Refer to Table 3 for valid  $D_{IN}$  during a write operation.

8. Never hold OE# low and WE# low at the same timing.

Table 2 Command Definitions(10)

	Bus Cycles		Fi	irst Bus Cyc	ele	Sec	cond Bus Cy	
Command	Req'd.	Notes	Oper <sup>(1)</sup>	Addr <sup>(2)</sup>	Data <sup>(3)</sup>	Oper <sup>(1)</sup>	Addr <sup>(2)</sup>	Data <sup>(3)</sup>
Read Array/Reset	1		Write	Х	FFH			
Read Identifier Codes	≥2	4	Write	Х	90H	Read	IA	ID
Read Status Register	2		Write	Х	70H	Read	X	SRD
Clear Status Register	1		Write	Х	50H			
Block Erase	2	5	Write	Х	20H	Write	BA	D0H
Full Chip Erase	2		Write	Х	30H	Write	X	D0H
Word/Byte Write	2	5,6	Write	Х	40H or 10H	Write	WA	WD
Block Erase and Word/Byte Write Suspend	1	5	Write	X	B0H			
Block Erase and Word/Byte Write Resume	1	5	Write	X	D0H			
Set Block Lock-Bit	2	8	Write	Х	60H	Write	BA	01H
Clear Block Lock-Bits	2	7,8	Write	Х	60H	Write	X	D0H
Set Permanent Lock-Bit	2	9	Write	Х	60H	Write	X	F1H

NOTES:

1. BUS operations are defined in Table 2.1 and Table 2.2.

 X=Any valid address within the device. IA=Identifier Code Address: see Figure 4. BA=Address within the block being erased. WA=Address of memory location to be written.

 SRD=Data read from status register. See Table 6 for a description of the status register bits. WD=Data to be written at location WA. Data is latched on the rising edge of WE# or CE# (whichever goes high first). ID=Data read from identifier codes.

- 4. Following the Read Identifier Codes command, read operations access manufacturer, device, block lock configuration and permanent lock configuration codes. See Section 4.2 for read identifier code data.
- 5. If WP# is  $V_{IL}$ , boot blocks are locked without block lock-bits state. If WP# is  $V_{IH}$ , boot blocks are locked by block lock-bits. The parameter and main blocks are locked by block lock-bits without WP# state.
- 6. Either 40H or 10H are recognized by the WSM as the word/byte write setup.
- 7. The clear block lock-bits operation simultaneously clears all block lock-bits.
- 8. If the permanent lock-bit is set, Set Block Lock-Bit and Clear Block Lock-Bits commands can not be done.
- 9. Once the permanent lock-bit is set, permanent lock-bit reset is unable.
- 10. Commands other than those shown above are reserved by SHARP for future device implementations and should not be used.

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### 4.1 Read Array Command

Upon initial device power-up and after exit from reset mode, the device defaults to read array mode. This operation is also initiated by writing the Read Array command. The device remains enabled for reads until another command is written. Once the internal WSM has started a block erase, full chip erase, word/byte write or lock-bit configuration the device will not recognize the Read Array command until the WSM completes its operation unless the WSM is suspended via an Erase Suspend or Word/Byte Write Suspend command. The Read Array command functions independently of the  $V_{CCW}$  voltage and RP# can be  $V_{IH}$ .

### 4.2 Read Identifier Codes Command

The identifier code operation is initiated by writing the Read Identifier Codes command. Following the command write, read cycles from addresses shown in Figure 4 retrieve the manufacturer, device, block lock configuration and permanent lock configuration codes (see Table 4 for identifier code values). To terminate the operation, write another valid command. Like the Read Array command, the Read Identifier Codes command functions independently of the V<sub>CCW</sub> voltage and RP# can be V<sub>IH</sub>. Following the Read Identifier Codes command, the following information can be read:

 Table 4. Identifier Codes

	1	
Code	Address <sup>(2)</sup>	Data <sup>(3)</sup>
	$[A_{19}-A_0]$	$[DQ_7 - DQ_0]$
Manufacture Code	00000H	B0H
Device Code	00001H	E9H
Block Lock Configuration	BA <sup>(1)</sup> +2	
•Block is Unlocked		DQ <sub>0</sub> =0
•Block is Locked		DQ <sub>0</sub> =1
•Reserved for Future Use		DQ <sub>1-7</sub>
Permanent Lock Configuration	00003H	
•Device is Unlocked		DQ <sub>0</sub> =0
•Device is Locked		DQ <sub>0</sub> =1
•Reserved for Future Use		DQ <sub>1-7</sub>

NOTE:

- 1. BA selects the specific block lock configuration code to be read. See Figure 4 for the device identifier code memory map.
- 2.  $A_{-1}$  don't care in byte mode.
- 3.  $DQ_{15}$ - $DQ_8$  outputs 00H in word mode.

#### 4.3 Read Status Register Command

The status register may be read to determine when a block erase, full chip erase, word/byte write or lock-bit configuration is complete and whether the operation completed successfully. It may be read at any time by writing the Read Status Register command. After writing this command, all subsequent read operations output data from the status register until another valid command is written. The status register contents are latched on the falling edge of OE# or CE#, whichever occurs. OE# or CE# must toggle to  $V_{IH}$  before further reads to update the status register latch. The Read Status Register command functions independently of the  $V_{CCW}$  voltage. RP# can be  $V_{IH}$ .

#### 4.4 Clear Status Register Command

Status register bits SR.5, SR.4, SR.3 or SR.1 are set to "1"s by the WSM and can only be reset by the Clear Status Register command. These bits indicate various failure conditions (see Table 6). By allowing system software to reset these bits, several operations (such as cumulatively erasing multiple blocks or writing several words/bytes in sequence) may be performed. The status register may be polled to determine if an error occurred during the sequence.

To clear the status register, the Clear Status Register command (50H) is written. It functions independently of the applied  $V_{CCW}$  Voltage. RP# can be  $V_{IH}$ . This command is not functional during block erase or word/byte write suspend modes.

#### 4.5 Block Erase Command

Erase is executed one block at a time and initiated by a two-cycle command. A block erase setup is first written, followed by an block erase confirm. This command sequence requires appropriate sequencing and an address within the block to be erased (erase changes all block data to FFFFH/FFH). Block preconditioning, erase, and verify are handled internally by the WSM (invisible to the system). After the two-cycle block erase sequence is written, the device automatically outputs status register data when read (see Figure 5). The CPU can detect block erase completion by analyzing the output data of the RY/BY# pin or status register bit SR.7.

When the block erase is complete, status register bit SR.5 should be checked. If a block erase error is detected, the status register should be cleared before system software attempts corrective actions. The CUI remains in read status register mode until a new command is issued.

This two-step command sequence of set-up followed by execution ensures that block contents are not accidentally erased. An invalid Block Erase command sequence will result in both status register bits SR.4 and SR.5 being set to "1". Also, reliable block erasure can only occur when  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ . In the absence of this high voltage, block contents are protected against erasure. If block erase is attempted while  $V_{CCW} \leq V_{CCWLK}$ , SR.3 and SR.5 will be set to "1". Successful block erase requires for boot blocks that WP# is  $V_{IH}$  and the corresponding block lock-bit be cleared. In parameter and main blocks case, it must be cleared the corresponding block lock-bit. If block erase is attempted when the excepting above conditions, SR.1 and SR.5 will be set to "1".

#### 4.6 Full Chip Erase Command

This command followed by a confirm command erases all of the unlocked blocks. A full chip erase setup (30H) is first written, followed by a full chip erase confirm (D0H). After a confirm command is written, device erases the all unlocked blocks block by block. This command sequence requires appropriate sequencing. Block preconditioning, erase and verify are handled internally by the WSM (invisible to the system). After the two-cycle full chip erase sequence is written, the device automatically outputs status register data when read (see Figure 6). The CPU can detect full chip erase completion by analyzing the output data of the RY/BY# pin or status register bit SR.7.

When the full chip erase is complete, status register bit SR.5 should be checked. If erase error is detected, the status register should be cleared before system software attempts corrective actions. The CUI remains in read

status register mode until a new command is issued. If error is detected on a block during full chip erase operation, WSM stops erasing. Full chip erase operation start from lower address block, finish the higher address block. Full chip erase can not be suspended.

This two-step command sequence of set-up followed by execution ensures that block contents are not accidentally erased. An invalid Full Chip Erase command sequence will result in both status register bits SR.4 and SR.5 being set to "1". Also, reliable full chip erasure can only occur when  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ . In the absence of this high voltage, block contents are protected against erasure. If full chip erase is attempted while  $V_{CCW} \leq V_{CCWLK}$ , SR.3 and SR.5 will be set to "1". Successful full chip erase requires for boot blocks that WP# is  $V_{IH}$  and the corresponding block lock-bit be cleared. In parameter and main blocks case, it must be cleared the corresponding block lock-bit. If all blocks are locked, SR.1 and SR.5 will be set to "1".

#### 4.7 Word/Byte Write Command

Word/Byte write is executed by a two-cycle command sequence. Word/Byte write setup (standard 40H or alternate 10H) is written, followed by a second write that specifies the address and data (latched on the rising edge of WE#). The WSM then takes over, controlling the word/byte write and write verify algorithms internally. After the word/byte write sequence is written, the device automatically outputs status register data when read (see Figure 7). The CPU can detect the completion of the word/byte write event by analyzing the RY/BY# pin or status register bit SR.7.

When word/byte write is complete, status register bit SR.4 should be checked. If word/byte write error is detected, the status register should be cleared. The internal WSM verify only detects errors for "1"s that do not successfully write to "0"s. The CUI remains in read status register mode until it receives another command.

Reliable word/byte writes can only occur when  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ . In the absence of this high voltage, memory contents are protected against word/byte writes. If word/byte write is attempted while  $V_{CCW} \leq V_{CCWLK}$ , status register bits SR.3 and SR.4 will be set to "1". Successful word/byte write requires for boot blocks that WP# is  $V_{IH}$  and the corresponding block lockbit be cleared. In parameter and main blocks case, it must be cleared the corresponding block lock-bit. If word/byte write is attempted when the excepting above conditions, SR.1 and SR.4 will be set to "1".

### 4.8 Block Erase Suspend Command

The Block Erase Suspend command allows block-erase interruption to read or word/byte write data in another block of memory. Once the block erase process starts, writing the Block Erase Suspend command requests that the WSM suspend the block erase sequence at a predetermined point in the algorithm. The device outputs status register data when read after the Block Erase Suspend command is written. Polling status register bits SR.7 and SR.6 can determine when the block erase operation has been suspended (both will be set to "1"). RY/BY# will also transition to High Z. Specification t<sub>WHRZ2</sub> defines the block erase suspend latency.

When Block Erase Suspend command write to the CUI, if block erase was finished, the device places read array mode. Therefore, after Block Erase Suspend command write to the CUI, Read Status Register command (70H) has to write to CUI, then status register bit SR.6 should be checked for places the device in suspend mode.

At this point, a Read Array command can be written to read data from blocks other than that which is suspended. A Word/Byte Write command sequence can also be issued during erase suspend to program data in other blocks. Using the Word/Byte Write Suspend command (see Section 4.9), a word/byte write operation can also be suspended. During a word/byte write operation with block erase suspended, status register bit SR.7 will return to "0" and the RY/BY# output will transition to  $V_{OL}$ . However, SR.6 will remain "1" to indicate block erase suspend status.

The only other valid commands while block erase is suspended are Read Status Register and Block Erase Resume. After a Block Erase Resume command is written to the flash memory, the WSM will continue the block erase process. Status register bits SR.6 and SR.7 will automatically clear and RY/BY# will return to  $V_{OL}$ . After the Erase Resume command is written, the device automatically outputs status register data when read (see Figure 8).  $V_{CCW}$  must remain at  $V_{CCWH1/2}$  (the same  $V_{CCW}$  level used for block erase) while block erase is suspended. RP# must also remain at  $V_{IH}$ . WP# must also remain at  $V_{IL}$  or  $V_{IH}$  (the same WP# level used for block erase). Block erase cannot resume until word/byte write operations initiated during block erase suspend have completed.

If the period of from Block Erase Resume command write to the CUI till Block Erase Suspend command write to the CUI be short and done again and again, erase time be prolonged.

### 4.9 Word/Byte Write Suspend Command

The Word/Byte Write Suspend command allows word/byte write interruption to read data in other flash memory locations. Once the word/byte write process starts, writing the Word/Byte Write Suspend command requests that the WSM suspend the Word/Byte write sequence at a predetermined point in the algorithm. The device continues to output status register data when read after the Word/Byte Write Suspend command is written. Polling status register bits SR.7 and SR.2 can determine when the word/byte write operation has been suspended (both will be set to "1"). RY/BY# will also transition to High Z. Specification t<sub>WHRZ1</sub> defines the word/byte write suspend latency.

When Word/Byte Write Suspend command write to the CUI, if word/byte write was finished, the device places read array mode. Therefore, after Word/Byte Write Suspend command write to the CUI, Read Status Register command (70H) has to write to CUI, then status register bit SR.2 should be checked for places the device in suspend mode.

At this point, a Read Array command can be written to read data from locations other than that which is suspended. The only other valid commands while word/byte write is suspended are Read Status Register and Word/Byte Write Resume. After Word/Byte Write Resume command is written to the flash memory, the WSM will continue the word/byte write process. Status register bits SR.2 and SR.7 will automatically clear and RY/BY# will return to  $V_{OL}$ . After the Word/Byte Write Resume command is written, the device automatically outputs status register data when read (see Figure 9).  $V_{CCW}$  must remain at  $V_{CCWH1/2}$  (the same  $V_{CCW}$  level used for word/byte write) while in word/byte write suspend mode. RP# must also remain at  $V_{IH}$ . WP# must also remain at  $V_{IL}$  or  $V_{IH}$  (the same WP# level used for word/byte write).

If the period of from Word/Byte Write Resume command write to the CUI till Word/Byte Write Suspend command write to the CUI be short and done again and again, write time be prolonged.

#### 4.10 Set Block and Permanent Lock-Bit Commands

A flexible block locking and unlocking scheme is enabled via a combination of block lock-bits, a permanent lock-bit and WP# pin. The block lock-bits and WP# pin gates program and erase operations while the permanent lock-bit gates block-lock bit modification. With the permanent lock-bit not set, individual block lock-bits can be set using the Set Block Lock-Bit command. The Set Permanent Lock-Bit command, sets the permanent lock-bit. After the permanent lock-bit is set, block lock-bits and locked block contents cannot altered. See Table 5 for a summary of hardware and software write protection options.

Set block lock-bit and permanent lock-bit are executed by a two-cycle command sequence. The set block or permanent lock-bit setup along with appropriate block or device address is written followed by either the set block lock-bit confirm (and an address within the block to be locked) or the set permanent lock-bit confirm (and any device address). The WSM then controls the set lock-bit algorithm. After the sequence is written, the device automatically outputs status register data when read (see Figure 10). The CPU can detect the completion of the set lock-bit event by analyzing the RY/BY# pin output or status register bit SR.7.

When the set lock-bit operation is complete, status register bit SR.4 should be checked. If an error is detected, the status register should be cleared. The CUI will remain in read status register mode until a new command is issued.

This two-step sequence of set-up followed by execution ensures that lock-bits are not accidentally set. An invalid Set Block or Permanent Lock-Bit command will result in status register bits SR.4 and SR.5 being set to "1". Also, reliable operations occur only when  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ . In the absence of this high voltage, lock-bit contents are protected against alteration.

A successful set block lock-bit operation requires that the permanent lock-bit be cleared. If it is attempted with the permanent lock-bit set, SR.1 and SR.4 will be set to "1" and the operation will fail.

#### 4.11 Clear Block Lock-Bits Command

All set block lock-bits are cleared in parallel via the Clear Block Lock-Bits command. With the permanent lock-bit not set, block lock-bits can be cleared using only the Clear Block Lock-Bits command. If the permanent lock-bit is set, block lock-bits cannot cleared. See Table 5 for a summary of hardware and software write protection options.

Clear block lock-bits operation is executed by a two-cycle command sequence. A clear block lock-bits setup is first written. After the command is written, the device automatically outputs status register data when read (see Figure 11). The CPU can detect completion of the clear block lock-bits event by analyzing the RY/BY# Pin output or status register bit SR.7.

When the operation is complete, status register bit SR.5 should be checked. If a clear block lock-bit error is detected, the status register should be cleared. The CUI will remain in read status register mode until another command is issued.

This two-step sequence of set-up followed by execution ensures that block lock-bits are not accidentally cleared. An invalid Clear Block Lock-Bits command sequence will result in status register bits SR.4 and SR.5 being set to "1". Also, a reliable clear block lock-bits operation can only occur when  $V_{CC}=2.7V-3.6V$  and  $V_{CCW}=V_{CCWH1/2}$ . If a clear block lock-bits operation is attempted while  $V_{CCW} \leq V_{CCWLK}$ , SR.3 and SR.5 will be set to "1". In the absence of this high voltage, the block lock-bits content are protected against alteration. A successful clear block lock-bits operation requires that the permanent lock-bit is not set. If it is attempted with the permanent lock-bit set, SR.1 and SR.5 will be set to "1" and the operation will fail.

If a clear block lock-bits operation is aborted due to  $V_{CCW}$  or  $V_{CC}$  transitioning out of valid range or RP# active transition, block lock-bit values are left in an undetermined state. A repeat of clear block lock-bits is required to initialize block lock-bit contents to known values. Once the permanent lock-bit is set, it cannot be cleared.

#### 4.12 Block Locking by the WP#

This Boot Block Flash memory architecture features two hardware-lockable boot blocks so that the kernel code for the system can be kept secure while other blocks are programmed or erased as necessary.

The lockable two boot blocks are locked when WP#= $V_{IL}$ ; any program or erase operation to a locked block will

			1 au	ne 5. write	e Protec	ction Alternatives
Operation	V <sub>CCW</sub>	RP#	Permanent Lock-Bit	Block Lock-bit	WP#	Effect
Block Erase	≤V <sub>CCWLK</sub>	Х	X	X	X	All Blocks Locked.
or	>V <sub>CCWLK</sub>	V <sub>IL</sub>	X	Х	X	All Blocks Locked.
Word/Byte		V <sub>IH</sub>	Х	0	V <sub>IL</sub>	2 Boot Blocks Locked.
Write					V <sub>IH</sub>	Block Erase and Word/Byte Write Enabled.
				1	V <sub>IL</sub>	Block Erase and Word/Byte Write Disabled.
					V <sub>IH</sub>	Block Erase and Word/Byte Write Disabled.
Full Chip	$\leq V_{CCWLK}$	Х	X	X	X	All Blocks Locked.
Erase	>V <sub>CCWLK</sub>	V <sub>IL</sub>	X	X	X	All Blocks Locked.
		V <sub>IH</sub>	X	Х	V <sub>IL</sub>	All Unlocked Blocks are Erased. 2 Boot Blocks and Locked Blocks are NOT Erased.
					V <sub>IH</sub>	All Unlocked Blocks are Erased, Locked Blocks are NOT Erased.
Set Block	≤V <sub>CCWLK</sub>	Х	X	X	X	Set Block Lock-Bit Disabled.
Lock-Bit	>V <sub>CCWLK</sub>	V <sub>IL</sub>	Х	Х	X	Set Block Lock-Bit Disabled.
		V <sub>IH</sub>	0	X	X	Set Block Lock-Bit Enabled.
			1	Х	X	Set Block Lock-Bit Disabled.
Clear Block	$\leq V_{CCWLK}$	Х	X	X	X	Clear Block Lock-Bits Disabled.
Lock-Bits	>V <sub>CCWLK</sub>	V <sub>IL</sub>	Х	Х	X	Clear Block Lock-Bits Disabled.
		V <sub>IH</sub>	0	X	X	Clear Block Lock-Bits Enabled.
			1	X	X	Clear Block Lock-Bits Disabled.
Set	≤V <sub>CCWLK</sub>	Х	X	X	X	Set Permanent Lock-Bit Disabled.
Permanent	>V <sub>CCWLK</sub>	V <sub>IL</sub>	Х	Х	X	Set Permanent Lock-Bit Disabled.
Lock-Bit		V <sub>IH</sub>	X	X	X	Set Permanent Lock-Bit Enabled.

Table 5. Write Protection Alternatives

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result in an error, which will be reflected in the status register. For top configuration, the top two boot blocks are

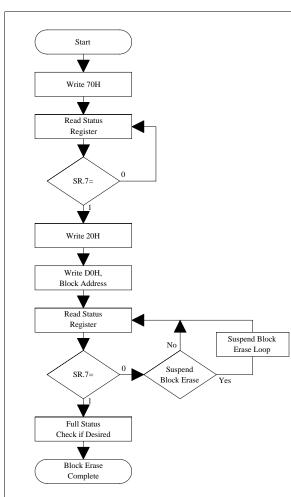
lockable. For the bottom configuration, the bottom two

boot blocks are lockable. If WP# is  $V_{IH}$  and block lockbit is not set, boot blocks can be programmed or erased normally (Unless  $V_{CCW}$  is below  $V_{CCWLK}$ ). WP# is valid only two boot blocks, other blocks are not affected.

### LHF16JTH

WSMS	BESS	ECBLBS	WBWSLBS	VCCWS	WBWSS	DPS	R
7	6	5	4	3	2	1	0
					NOTES	S:	
SR.7 = WRIT 1 = Ready 0 = Busy	E STATE MAC	HINE STATUS	(WSMS)	erase, word/by	# or SR.7 to deto yte write or lock- valid while SR.7=	bit configuratio	
1 = Block	K ERASE SUSI Erase Suspended Erase in Progres	d	(BESS)				
STAT $1 = Error i$ $Lock-$ $0 = Succes$	E AND CLEAR US (ECBLBS) n Block Erase, F Bits ssful Block Erase Lock-Bits	Full Chip Erase	or Clear Block	erase or lock-l	nd SR.4 are "1"s bit configuration uence was entere	attempt, an imp	
<ul> <li>SR.4 = WORD/BYTE WRITE AND SET LOCK-BIT STATUS (WBWSLBS)</li> <li>1 = Error in Word/Byte Write or Set Block/Permanent Lock-Bit</li> <li>0 = Successful Word/Byte Write or Set Block/Permanent Lock-Bit</li> </ul>				level. The WS only after Blo Lock-Bit Con guaranteed to	provide a contin M interrogates a ck Erase, Full Ch figuration comm reports accurate	nd indicates the hip Erase, Word and sequences.	V <sub>CCW</sub> level /Byte Write or SR.3 is not
$SR.3 = V_{CCW}$ $1 = V_{CCW}$ $0 = V_{CCW}$	STATUS (VCC Low Detect, Op OK	WS) eration Abort			provide a contin		
<pre>SR.2 = WORD/BYTE WRITE SUSPEND STATUS   (WBWSS)   1 = Word/Byte Write Suspended   0 = Word/Byte Write in Progress/Completed</pre>				the permanent Block Erase, I Configuration depending on	c-bit and WP# va clock-bit, block l Full Chip Erase, v command seque the attempted op	ock-bit and WP Word/Byte Wri nces. It informs eration, if the b	# only after te or Lock-Bit the system, lock lock-bit is
1 = Block	CE PROTECT S Lock-Bit, Perma Detected, Operat	anent Lock-Bit a	nd/or WP#	the block lock writing the Re	t lock-bit is set an and permanent l ad Identifier Coo l block lock-bit s	ock configurati	on codes after
SR.0 = RESE	RVED FOR FU	FURE ENHANG	CEMENTS (R)	SR.0 is reservention when polling to	ed for future use		nasked out





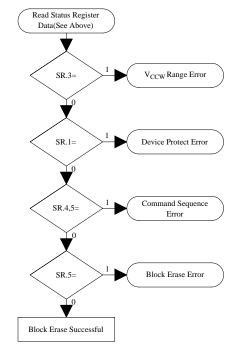
Bus Operation	Command	Comments www.Data\$heet4U.com
Write	Read Status Register	Data=70H Addr=X
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Write	Erase Setup	Data=20H Addr=X
Write	Erase Confirm	Data=D0H Addr=Within Block to be Erased
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Repeat for subseq	uent block erasures.	

Repeat for subsequent block erasures.

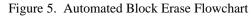
Full status check can be done after each block erase or after a sequence of block erasures.

Write FFH after the last operation to place device in read array mode.

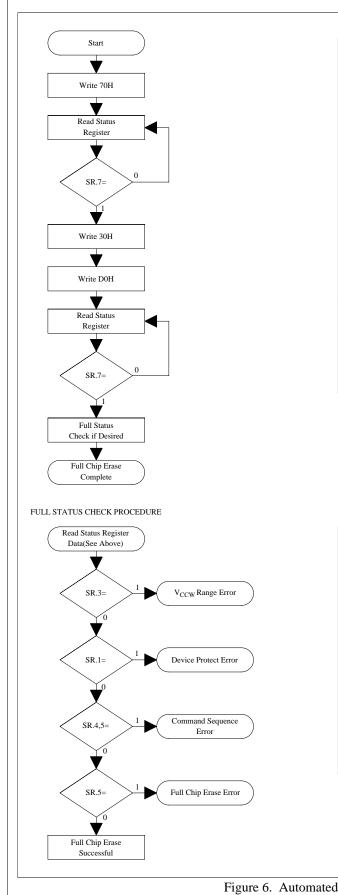
FULL STATUS CHECK PROCEDURE



Bus Operation	Command	Comments
Standby		Check SR.3 1=V <sub>CCW</sub> Error Detect
Standby		Check SR.1 1=Device Protect Detect
Standby		Check SR.4,5 Both 1=Command Sequence Error
Standby		Check SR.5 1=Block Erase Error
where multiple	blocks are erased before full	y the Clear Status Register Command in cases I status is checked. efore attempting retry or other error recovery.



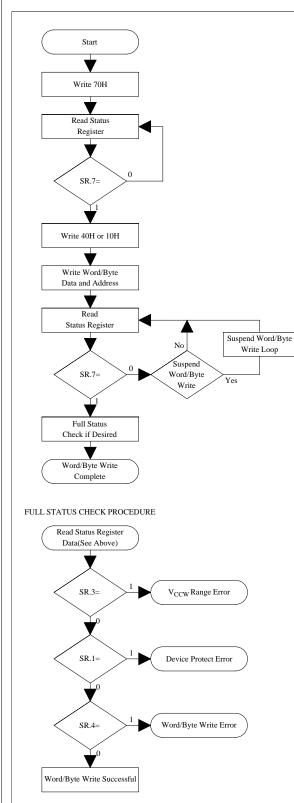




Bus Operation	Command	Comments www.Data\$heet4U.com			
Write	Read Status Register	Data=70H Addr=X			
Read		Status Register Data			
Standby		Check SR.7 1=WSM Ready 0=WSM Busy			
Write	Full Chip Erase Setup	Data=30H Addr=X			
Write	Full Chip Erase Confirm	Data=D0H Addr=X			
Read		Status Register Data			
Standby		Check SR.7 1=WSM Ready 0=WSM Busy			
	Full status check can be done after each full chip erase. Write FFH after the last operation to place device in read array mode.				

Bus Operation	Command	Comments
Standby		Check SR.3 1=V <sub>CCW</sub> Error Detect
Standby		Check SR.1 1=Device Protect Detect (All Blocks are locked)
Standby		Check SR.4,5 Both 1=Command Sequence Error
Standby		Check SR.5 1=Full Chip Erase Error
where multiple	blocks are erased before full	the Clear Status Register Command in cases status is checked. fore attempting retry or other error recovery.
	rase Flowchart	





	1	
Bus Operation	Command	Comments www.Data\$heet4U.c
Write	Read Status Register	Data=70H Addr=X
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Write	Setup Word/Byte Write	Data=40H or 10H Addr=X
Write	Word/Byte Write	Data=Data to Be Written Addr=Location to Be Written
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
SR full status che word/byte writ	tes.	ord/byte write, or after a sequence of ation to place device in read array mode.
Bus Operation	Command	Comments
Standby		Check SR.3 1=V <sub>CCW</sub> Error Detect
Standby		Check SR.1 1=Device Protect Detect
Standby		Check SR.4

1=Data Write Error

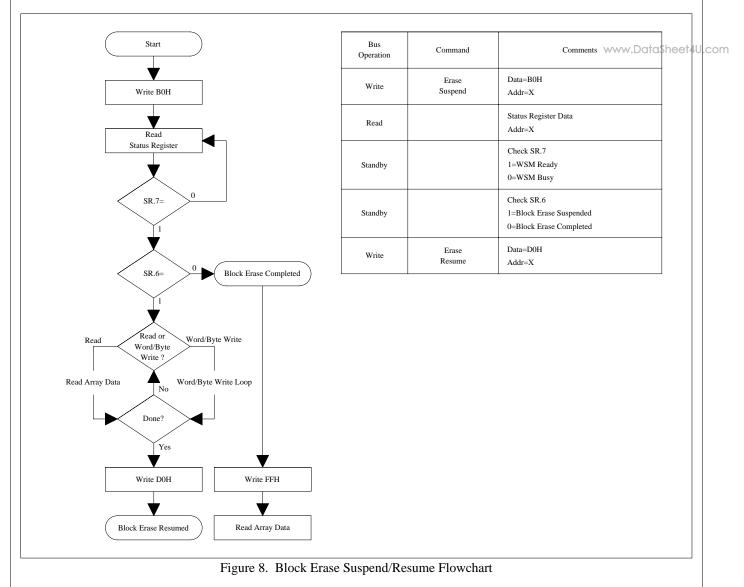
SR.4, SR.3 and SR.1 are only cleared by the Clear Status Register command in cases

If error is detected, clear the Status Register before attempting retry or other error recovery.

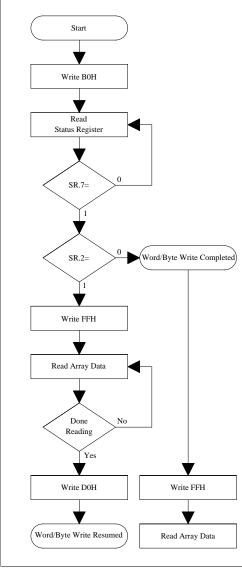
where multiple locations are written before full status is checked.

Figure 7. Automated Word/Byte Write Flowchart

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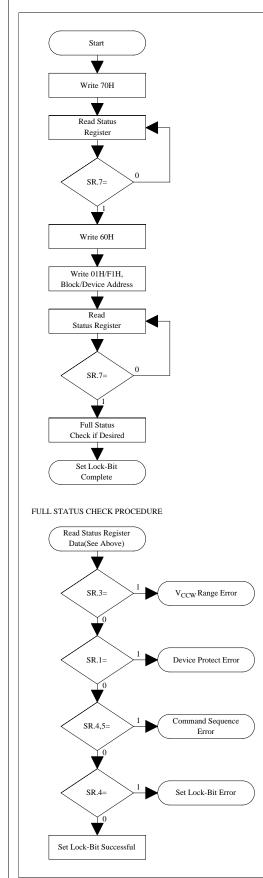




			.		
Bus Operation	Command	Comments www.Data	Sheet4	U.	com
Write	Word/Byte Write Suspend	Data=B0H Addr=X			
Read		Status Register Data Addr=X			
Standby		Check SR.7 1=WSM Ready 0=WSM Busy			
Standby		Check SR.2 1=Word/Byte Write Suspended 0=Word/Byte Write Completed			
Write	Read Array	Data=FFH Addr=X			
Read		Read Array locations other than that being written.			
Write	Word/Byte Write Resume	Data=D0H Addr=X			

Figure 9. Word/Byte Write Suspend/Resume Flowchart





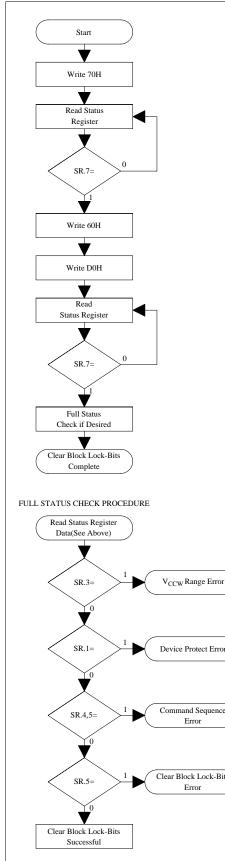
Bus Operation	Command	Comments www.Data\$heet4U.com
Write	Read Status Register	Data=70H Addr=X
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Write	Set Block/Permanent Lock-Bit Setup	Data=60H Addr=X
Write	Set Block or Permanent Lock-Bit Confirm	Data=01H(Block), F1H(Permanent) Addr=Block Address(Block), Device Address(Permanent)
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
		bit set operation or after a sequence of

Write FFH after the last lock-bit set operation to place device in read array mode.

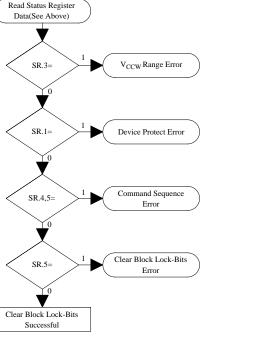
Bus Operation	Command	Comments		
Standby		Check SR.3 1=V <sub>CCW</sub> Error Detect		
Standby		Check SR.1 1=Device Protect Detect Permanent Lock-Bit is Set (Set Block Lock-Bit Operation)		
Standby		Check SR.4,5 Both 1=Command Sequence Error		
Standby		Check SR.4 1=Set Lock-Bit Error		
SR.5, SR.4, SR.3 and SR.1 are only cleared by the Clear Status Register command in cases where multiple lock-bits are set before full status is checked. If error is detected, clear the Status Register before attempting retry or other error recovery.				

Figure 10. Set Block and Permanent Lock-Bit Flowchart





Bus Operation	Command	Comments www.Data\$heet4U.com
Write	Read Status Register	Data=70H Addr=X
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Write	Clear Block Lock-Bits Setup	Data=60H Addr=X
Write	Clear Block Lock-Bits Confirm	Data=D0H Addr=X
Read		Status Register Data
Standby		Check SR.7 1=WSM Ready 0=WSM Busy
Write FFH after t	he Clear Block Lock-Bits op	peration to place device in read array mode.



Bus Operation	Command	Comments					
Standby		Check SR.3 1=V <sub>CCW</sub> Error Detect					
Standby		Check SR.1 1=Device Protect Detect Permanent Lock-Bit is Set					
Standby		Check SR.4,5 Both 1=Command Sequence Error					
Standby		Check SR.5 1=Clear Block Lock-Bits Error					
		y the Clear Status Register command. efore attempting retry or other error recovery.					



### 5 DESIGN CONSIDERATIONS

#### 5.1 Three-Line Output Control

The device will often be used in large memory arrays. SHARP provides three control inputs to accommodate multiple memory connections. Three-line control provides for:

- a. Lowest possible memory power dissipation.
- b. Complete assurance that data bus contention will not occur.

To use these control inputs efficiently, an address decoder should enable CE# while OE# should be connected to all memory devices and the system's READ# control line. This assures that only selected memory devices have active outputs while deselected memory devices are in standby mode. RP# should be connected to the system POWERGOOD signal to prevent unintended writes during system power transitions. POWERGOOD should also toggle during system reset.

#### 5.2 RY/BY# and WSM Polling

RY/BY# is an open drain output that should be connected to V<sub>CC</sub> by a pull up resistor to provides a hardware method of detecting block erase, full chip erase, word/byte write and lock-bit configuration completion. It transitions low after block erase, full chip erase, word/byte write or lock-bit configuration commands and returns to V<sub>OH</sub> (while RY/BY# is pull up) when the WSM has finished executing the internal algorithm.

RY/BY# can be connected to an interrupt input of the system CPU or controller. It is active at all times. RY/BY# is also High Z when the device is in block erase suspend (with word/byte write inactive), word/byte write suspend or reset modes.

#### 5.3 Power Supply Decoupling

Flash memory power switching characteristics require careful device decoupling. System designers are interested in three supply current issues; standby current levels, active current levels and transient peaks produced by falling and rising edges of CE# and OE#. Transient current magnitudes depend on the device outputs' capacitive and inductive loading. Two-line control and proper decoupling capacitor selection will suppress transient voltage peaks. Each device should have a 0.1µF ceramic capacitor connected between its V<sub>CC</sub> and GND and between its V<sub>CCW</sub> and GND. These high-frequency, low inductance capacitors should be placed as close as possible to package leads. Additionally, for every eight devices, a 4.7µF electrolytic capacitor should be placed at the array's power supply connection between  $V_{CC}$  and GND. The bulk capacitor will overcome voltage slumps caused by PC board trace inductance.

#### 5.4 V<sub>CCW</sub> Trace on Printed Circuit Boards

Updating flash memories that reside in the target system requires that the printed circuit board designer pay attention to the  $V_{CCW}$  Power supply trace. The  $V_{CCW}$  pin supplies the memory cell current for word/byte writing and block erasing. Use similar trace widths and layout considerations given to the  $V_{CC}$  power bus. Adequate  $V_{CCW}$  supply traces and decoupling will decrease  $V_{CCW}$  voltage spikes and overshoots.

### 5.5 V<sub>CC</sub>, V<sub>CCW</sub>, RP# Transitions

Block erase, full chip erase, word/byte write and lock-bit configuration are not guaranteed if  $V_{CCW}$  falls outside of a valid  $V_{CCWH1/2}$  range,  $V_{CC}$  falls outside of a valid 2.7V-3.6V range, or RP# $\neq$ V<sub>IH</sub>. If  $V_{CCW}$  error is detected, status register bit SR.3 is set to "1" along with SR.4 or SR.5, depending on the attempted operation. If RP# transitions to  $V_{IL}$  during block erase, full chip erase, word/byte write or lock-bit configuration, RY/BY# will remain low until the reset operation is complete. Then, the operation will abort and the device will enter reset mode. The aborted operation may leave data partially altered. Therefore, the command sequence must be repeated after normal operation is restored. Device power-off or RP# transitions to  $V_{IL}$  clear the status register.

The CUI latches commands issued by system software and is not altered by  $V_{CCW}$  or CE# transitions or WSM actions. Its state is read array mode upon power-up, after exit from reset mode or after  $V_{CC}$  transitions below  $V_{LKO}$ .

### 5.6 Power-Up/Down Protection

The device is designed to offer protection against accidental block erase, full chip erase, word/byte write or lock-bit configuration during power transitions. Upon power-up, the device is indifferent as to which power supply ( $V_{CCW}$  or  $V_{CC}$ ) powers-up first. Internal circuitry resets the CUI to read array mode at power-up.

A system designer must guard against spurious writes for  $V_{CC}$  voltages above  $V_{LKO}$  when  $V_{CCW}$  is active. Since both WE# and CE# must be low for a command write, driving either to  $V_{IH}$  will inhibit writes. The CUI's two-step command sequence architecture provides added level of protection against data alteration.

In-system block lock and unlock capability prevents inadvertent data alteration. The device is disabled while  $RP\#=V_{IL}$  regardless of its control inputs state.

### 5.7 Power Dissipation

When designing portable systems, designers must consider battery power consumption not only during device operation, but also for data retention during system idle time. Flash memory's nonvolatility increases usable battery life because data is retained when system power is removed.

### 5.8 Data Protection Method

Noises having a level exceeding the limit specified in the specification may be generated under specific operating conditions on some systems. Such noises, when induced onto WE# signal or power supply, may be interpreted as false commands, causing undesired memory updating. To protect the data stored in the flash memory against unwanted overwriting, systems operating with the flash memory should have the following write protect designs, as appropriate:

1) Protecting data in specific block

When a lock bit is set, the corresponding block (includes the 2 boot blocks) is protected against overwriting. By setting a WP# to low, only the 2 boot blocks can be protected against overwriting. By using this feature, the flash memory space can be divided into the program section (locked section) and data section (unlocked section). The permanent lock bit can be used to prevent false block bit setting. For further information on setting/resetting lock-bit, refer to the specification. (See chapter 4.10 and 4.11.)

2) Data protection through  $V_{CCW}$ 

When the level of  $V_{CCW}$  is lower than  $V_{CCWLK}$  (lockout voltage), write operation on the flash memory is disabled. All blocks are locked and the data in the blocks are completely write protected. For the lockout voltage, refer to the specification. (See chapter 6.2.3.)

3) Data protection through RP#

When the RP# is kept low during read mode, the flash memory will be reset mode, then write protecting all blocks. When the RP# is kept low during power up and power down sequence such as voltage transition, write operation on the flash memory is disabled, write protecting all blocks. For the details of RP# control, refer to the specification. (See chapter 5.6 and 6.2.7.)

### 6 ELECTRICAL SPECIFICATIONS

#### 6.1 Absolute Maximum Ratings\*

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\*WARNING: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only. Operation beyond the "Operating" Conditions" is not recommended and extended exposure beyond the "Operating Conditions" may affect device reliability.

#### NOTES:

- 1. Operating temperature is for extended temperature product defined by this specification.
- 2. All specified voltages are with respect to GND. Minimum DC voltage is -0.5V on input/output pins and -0.2V on  $V_{CC}$  and  $V_{CCW}$  pins. During transitions, this level may undershoot to -2.0V for periods <20ns. Maximum DC voltage on input/output pins are  $V_{CC}$ +0.5V which, during transitions, may overshoot to  $V_{CC}$ +2.0V for periods <20ns.
- 3. Maximum DC voltage on  $V_{CCW}$  may overshoot to +13.0V for periods <20ns. Applying  $12V\pm0.3V$  to  $V_{CCW}$  during erase/write can only be done for a maximum of 1000 cycles on each block.  $V_{CCW}$  may be connected to  $12V\pm0.3V$  for a total of 80 hours maximum.
- 4. Output shorted for no more than one second. No more than one output shorted at a time.

#### 6.2 Operating Conditions

	Temperature and V <sub>CC</sub> Operating Conditions							
Symbol	SymbolParameterMin.Max.UnitTest Condition							
T <sub>A</sub>	Operating Temperature	-40	+85	°C	Ambient Temperature			
V <sub>CC</sub>	V <sub>CC</sub> Supply Voltage (2.7V-3.6V)	2.7	3.6	V				

### 6.2.1 CAPACITANCE<sup>(1)</sup>

	$T_A = +25^{\circ}C, f = 1MHz$							
Symbol	Symbol Parameter Typ. Max. Unit Condition							
C <sub>IN</sub>	Input Capacitance	7	10	pF	V <sub>IN</sub> =0.0V			
C <sub>OUT</sub>	Output Capacitance	9	12	pF	V <sub>OUT</sub> =0.0V			
NOTE								

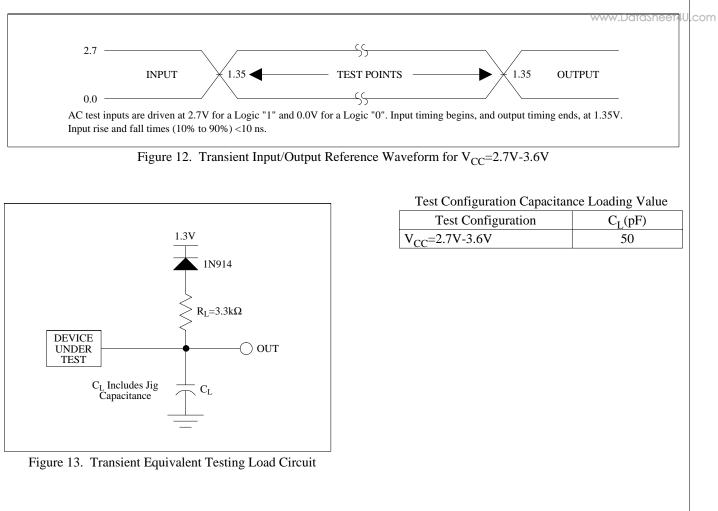
NOTE:

1. Sampled, not 100% tested.

### LHF16JTH

### 6.2.2 AC INPUT/OUTPUT TEST CONDITIONS

SHARP



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## 6.2.3 DC CHARACTERISTICS

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		DC Ch	aracteristics	1		www.DataSheet	
			V <sub>CC</sub> =2.7V-3.6V			Test	
Sym.	Parameter	Notes	Тур.	Max.	Unit	Conditions	
I <sub>LI</sub>	Input Load Current	1		±0.5	μΑ	V <sub>CC</sub> =V <sub>CC</sub> Max. V <sub>IN</sub> =V <sub>CC</sub> or GND	
I <sub>LO</sub>	Output Leakage Current	1		±0.5	μΑ	V <sub>CC</sub> =V <sub>CC</sub> Max. V <sub>OUT</sub> =V <sub>CC</sub> or GND	
I <sub>CCS</sub>	V <sub>CC</sub> Standby Current	1,3,6	2	15	μΑ	CMOS Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max. CE#=RP#=V <sub>CC</sub> ±0.2V	
			0.2	2	mA	TTL Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max. CE#=RP#=V <sub>IH</sub>	
I <sub>CCAS</sub>	V <sub>CC</sub> Auto Power-Save Current	1,5,6	2	15	μΑ	CMOS Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max. CE#=GND±0.2V	
I <sub>CCD</sub>	V <sub>CC</sub> Reset Power-Down Current	1	2	15	μΑ	RP#=GND±0.2V I <sub>OUT</sub> (RY/BY#)=0mA	
I <sub>CCR</sub>	V <sub>CC</sub> Read Current	1,6	15	25	mA	CMOS Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max., CE#=GND f=5MHz, I <sub>OUT</sub> =0mA	
				30	mA	TTL Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max., CE#=GND f=5MHz, I <sub>OUT</sub> =0mA	
I <sub>CCW</sub>	V <sub>CC</sub> Word/Byte Write or Set Lock-	1,7	5	17	mA	V <sub>CCW</sub> =2.7V-3.6V	
	Bit Current		5	12	mA	V <sub>CCW</sub> =11.7V-12.3V	
I <sub>CCE</sub>	V <sub>CC</sub> Block Erase, Full Chip Erase or	1,7	4	17	mA	V <sub>CCW</sub> =2.7V-3.6V	
	Clear Block Lock-Bits Current		4	12	mA	V <sub>CCW</sub> =11.7V-12.3V	
I <sub>CCWS</sub> I <sub>CCES</sub>	V <sub>CC</sub> Word/Byte Write or Block Erase Suspend Current	1,2	1	6	mA	CE#=V <sub>IH</sub>	
I <sub>CCWS</sub>	V <sub>CCW</sub> Standby or Read Current	1	$\pm 2$	±15	μΑ	$V_{CCW} \leq V_{CC}$	
I <sub>CCWR</sub>			10	200	μΑ	V <sub>CCW</sub> >V <sub>CC</sub>	
I <sub>CCWAS</sub>	V <sub>CCW</sub> Auto Power-Save Current	1,5,6	0.1	5	μΑ	CMOS Level Inputs V <sub>CC</sub> =V <sub>CC</sub> Max. CE#=GND±0.2V	
I <sub>CCWD</sub>	V <sub>CCW</sub> Reset Power-Down Current	1	0.1	5	μΑ	RP#=GND±0.2V	
I <sub>CCWW</sub>	V <sub>CCW</sub> Word/Byte Write or Set Lock- Bit Current	1,7	12	40 30	mA mA	V <sub>CCW</sub> =2.7V-3.6V V <sub>CCW</sub> =11.7V-12.3V	
I <sub>CCWE</sub>	V <sub>CCW</sub> Block Erase, Full Chip Erase	1,7	8	25	mA	V <sub>CCW</sub> =2.7V-3.6V	
CUME	or Clear Block Lock-Bits Current			20	mA	V <sub>CCW</sub> =11.7V-12.3V	
I <sub>CCWWS</sub> I <sub>CCWES</sub>	V <sub>CCW</sub> Word/Byte Write or Block Erase Suspend Current	1	10	200	μΑ	V <sub>CCW</sub> =V <sub>CCWH1/2</sub>	

# SHAR

DC Characteristics (Continued)

			V <sub>CC</sub> =2.7V-3.6V			www.DetaShoetdU.a
Sym.	Parameter	Notes	Min.	Max.	Unit	Test Conditions
V <sub>IL</sub>	Input Low Voltage	7	-0.5	0.8	V	
V <sub>IH</sub>	Input High Voltage	7	2.0	V <sub>CC</sub> +0.5	V	
V <sub>OL</sub>	Output Low Voltage	3,7		0.4	V	V <sub>CC</sub> =V <sub>CC</sub> Min. I <sub>OL</sub> =2.0mA
V <sub>OH1</sub>	Output High Voltage (TTL)	7	2.4		V	V <sub>CC</sub> =V <sub>CC</sub> Min. I <sub>OH</sub> =-2.0mA
V <sub>OH2</sub>	Output High Voltage (CMOS)	7	0.85 V <sub>CC</sub>		v	V <sub>CC</sub> =V <sub>CC</sub> Min. I <sub>OH</sub> =-2.5mA
			V <sub>CC</sub> -0.4		V	V <sub>CC</sub> =V <sub>CC</sub> Min. I <sub>OH</sub> =-100µA
V <sub>CCWLK</sub>	V <sub>CCW</sub> Lockout during Normal Operations	4,7		1.0	V	
V <sub>CCWH1</sub>	V <sub>CCW</sub> during Block Erase, Full Chip Erase, Word/Byte Write or Lock-Bit Configuration Operations		2.7	3.6	v	
V <sub>CCWH2</sub>	V <sub>CCW</sub> during Block Erase, Full Chip Erase, Word/Byte Write or Lock-Bit Configuration Operations	8	11.7	12.3	v	
V <sub>LKO</sub>	V <sub>CC</sub> Lockout Voltage		2.0		V	

NOTES:

1. All currents are in RMS unless otherwise noted. Typical values at nominal  $V_{CC}$  voltage and  $T_A$ =+25°C.

2. I<sub>CCWS</sub> and I<sub>CCES</sub> are specified with the device de-selected. If read or word/byte written while in erase suspend mode, the device's current draw is the sum of I<sub>CCWS</sub> or I<sub>CCES</sub> and I<sub>CCR</sub> or I<sub>CCW</sub>, respectively.

3. Includes RY/BY#.

4. Block erases, full chip erase, word/byte writes and lock-bit configurations are inhibited when  $V_{CCW} \leq V_{CCWLK}$ , and not guaranteed in the range between V<sub>CCWLK</sub>(max.) and V<sub>CCWH1</sub>(min.), between V<sub>CCWH1</sub>(max.) and V<sub>CCWH2</sub>(min.) and above V<sub>CCWH2</sub>(max.).

5. The Automatic Power Savings (APS) feature is placed automatically power save mode that addresses not switching more than 300ns while read mode.

6. About all of pin except describe Test Conditions, CMOS level inputs are either  $V_{CC} \pm 0.2V$  or GND $\pm 0.2V$ , TTL level inputs are either V<sub>IL</sub> or V<sub>IH</sub>. 7. Sampled, not 100% tested.

Applying 12V±0.3V to V<sub>CCW</sub> during erase/write can only be done for a maximum of 1000 cycles on each block. V<sub>CCW</sub> may be connected to 12V±0.3V for a total of 80 hours maximum.

### 6.2.4 AC CHARACTERISTICS - READ-ONLY OPERATIONS<sup>(1)</sup>

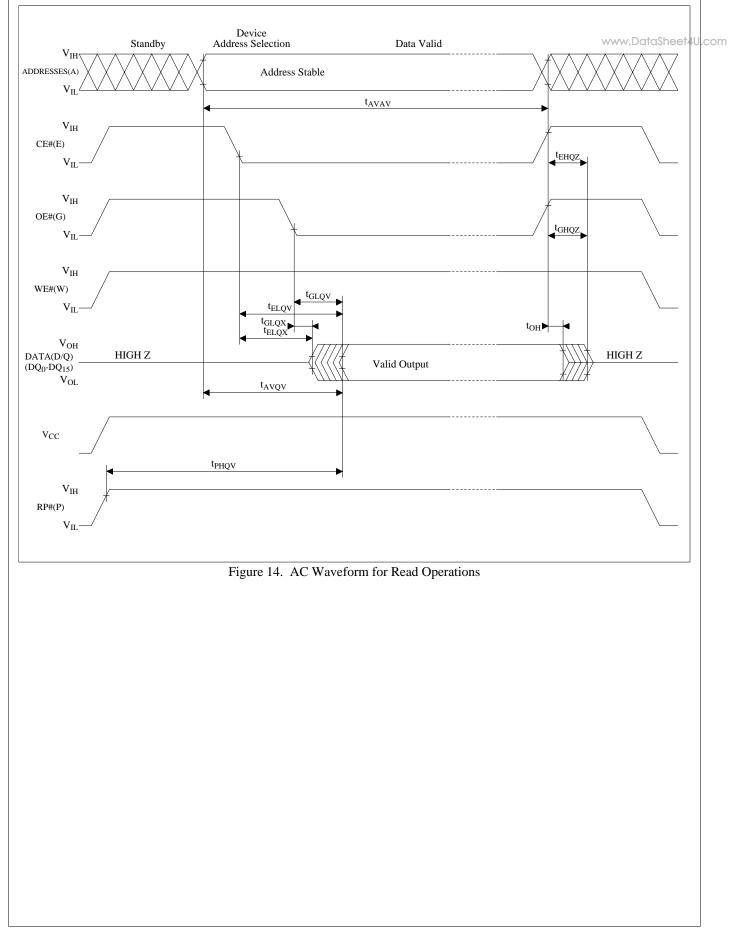
	$V_{\rm CC}$ =2.7V-3.6V, T <sub>A</sub> =-40°C to	+85°C		~~~~~	.DataSheet4l
Sym.	Parameter	Notes	Min.	Max.	Unit
t <sub>AVAV</sub>	Read Cycle Time		90		ns
t <sub>AVQV</sub>	Address to Output Delay			90	ns
t <sub>ELQV</sub>	CE# to Output Delay	2		90	ns
t <sub>PHQV</sub>	RP# High to Output Delay			600	ns
t <sub>GLQV</sub>	OE# to Output Delay	2		40	ns
t <sub>ELQX</sub>	CE# to Output in Low Z	3	0		ns
t <sub>EHQZ</sub>	CE# High to Output in High Z	3		40	ns
t <sub>GLQX</sub>	OE# to Output in Low Z	3	0		ns
t <sub>GHQZ</sub>	OE# High to Output in High Z	3		15	ns
t <sub>OH</sub>	Output Hold from Address, CE# or OE# Change, Whichever Occurs First	3	0		ns
t <sub>FVQV</sub>	BYTE# to Output Delay	3		90	ns
t <sub>FLQZ</sub>	BYTE# Low to Output in High Z	3		25	ns
t <sub>ELFV</sub>	CE# to BYTE# High or Low	3,4		5	ns

NOTES:

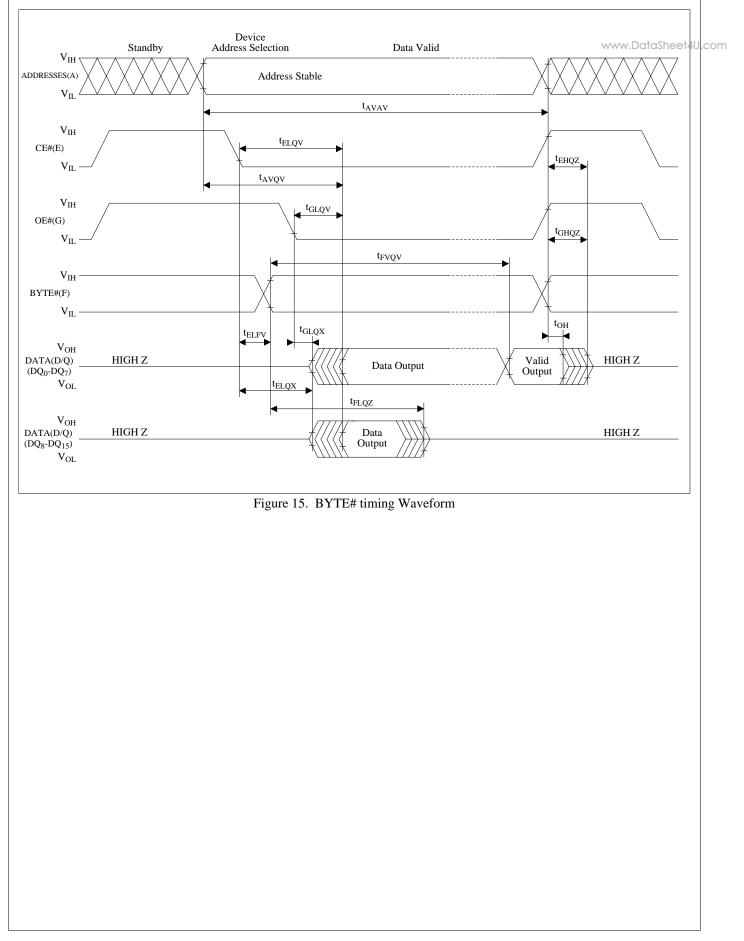
1. See AC Input/Output Reference Waveform for maximum allowable input slew rate.

OE# may be delayed up to t<sub>ELQV</sub>-t<sub>GLQV</sub> after the falling edge of CE# without impact on t<sub>ELQV</sub>.
 Sampled, not 100% tested.

4. If BYTE# transfer during reading cycle, exist the regulations separately.



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#### www.DataSheet4U.com $V_{CC}=2.7V-3.6V, T_{A}=-40^{\circ}C \text{ to }+85^{\circ}C$ Notes Sym. Parameter Min. Max. Unit Write Cycle Time 90 ns t<sub>AVAV</sub> RP# High Recovery to WE# Going Low 2 1 μs t<sub>PHWL</sub> CE# Setup to WE# Going Low 10 ns t<sub>ELWL</sub> WE# Pulse Width 50 ns t<sub>WLWH</sub> WP#V<sub>IH</sub> Setup to WE# Going High 2 100 t<sub>SHWH</sub> ns 2 V<sub>CCW</sub> Setup to WE# Going High 100 ns t<sub>VPWH</sub> Address Setup to WE# Going High 3 50 ns t<sub>AVWH</sub> 3 Data Setup to WE# Going High 50 t<sub>DVWH</sub> ns Data Hold from WE# High 0 ns t<sub>WHDX</sub> Address Hold from WE# High 0 ns t<sub>WHAX</sub> CE# Hold from WE# High 10 t<sub>WHEH</sub> ns WE# Pulse Width High 30 t<sub>WHWL</sub> ns WE# High to RY/BY# Going Low or SR.7 Going "0" 100 ns t<sub>WHRL</sub> Write Recovery before Read 0 ns tWHGL V<sub>CCW</sub> Hold from Valid SRD, RY/BY# High Z 0 2,4 ns t<sub>OVVL</sub> WP# V<sub>IH</sub> Hold from Valid SRD, RY/BY# High Z 2.4 0 ns t<sub>QVSL</sub> BYTE# Setup to WE# Going High 5 50 ns t<sub>FVWH</sub> BYTE# Hold from WE# High 5 90 ns t<sub>WHFV</sub>

### 6.2.5 AC CHARACTERISTICS - WRITE OPERATIONS<sup>(1)</sup>

NOTES:

1. Read timing characteristics during block erase, full chip erase, word/byte write and lock-bit configuration operations are the same as during read-only operations. Refer to AC Characteristics for read-only operations.

2. Sampled, not 100% tested.

3. Refer to Table 4 for valid A<sub>IN</sub> and D<sub>IN</sub> for block erase, full chip erase, word/byte write or lock-bit configuration.

4. V<sub>CCW</sub> should be held at V<sub>CCWH1/2</sub> until determination of block erase, full chip erase, word/byte write or lock-bit configuration success (SR.1/3/4/5=0).

5. If BYTE# switch during reading cycle, exist the regulations separately.

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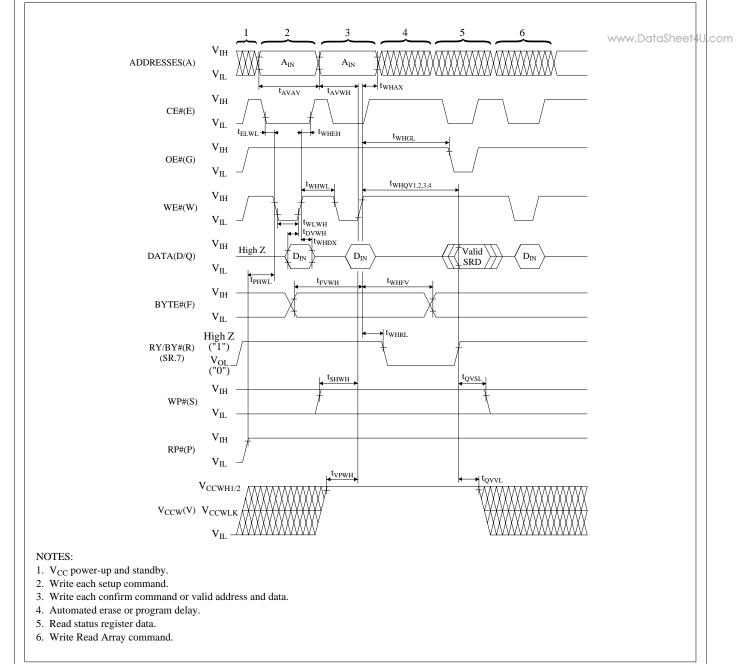


Figure 16. AC Waveform for WE#-Controlled Write Operations

## 6.2.6 ALTERNATIVE CE#-CONTROLLED WRITES<sup>(1)</sup>

	V <sub>CC</sub> =2.7V-3.6V, T <sub>A</sub> =-40°C	C to $+85^{\circ}C$		www.	DataSheet4U
Sym.	Parameter	Notes	Min.	Max.	Unit
t <sub>AVAV</sub>	Write Cycle Time		90		ns
t <sub>PHEL</sub>	RP# High Recovery to CE# Going Low	2	1		μs
t <sub>WLEL</sub>	WE# Setup to CE# Going Low		0		ns
t <sub>ELEH</sub>	CE# Pulse Width		65		ns
t <sub>SHEH</sub>	WP#V <sub>IH</sub> Setup to CE# Going High	2	100		ns
t <sub>VPEH</sub>	V <sub>CCW</sub> Setup to CE# Going High	2	100		ns
t <sub>AVEH</sub>	Address Setup to CE# Going High	3	50		ns
t <sub>DVEH</sub>	Data Setup to CE# Going High	3	50		ns
t <sub>EHDX</sub>	Data Hold from CE# High		0		ns
t <sub>EHAX</sub>	Address Hold from CE# High		0		ns
t <sub>EHWH</sub>	WE# Hold from CE# High		0		ns
t <sub>EHEL</sub>	CE# Pulse Width High		25		ns
t <sub>EHRL</sub>	CE# High to RY/BY# Going Low or SR.7 Going "0"			100	ns
t <sub>EHGL</sub>	Write Recovery before Read		0		ns
t <sub>OVVL</sub>	V <sub>CCW</sub> Hold from Valid SRD, RY/BY# High Z	2,4	0		ns
t <sub>QVSL</sub>	WP# V <sub>IH</sub> Hold from Valid SRD, RY/BY# High Z	2,4	0		ns
t <sub>FVEH</sub>	BYTE# Setup to CE# Going High	5	50		ns
t <sub>EHFV</sub>	BYTE# Hold from CE# High	5	90		ns
NOTES:					·

1. In systems where CE# defines the write pulse width (within a longer WE# timing waveform), all setup, hold, and inactive WE# times should be measured relative to the CE# waveform.

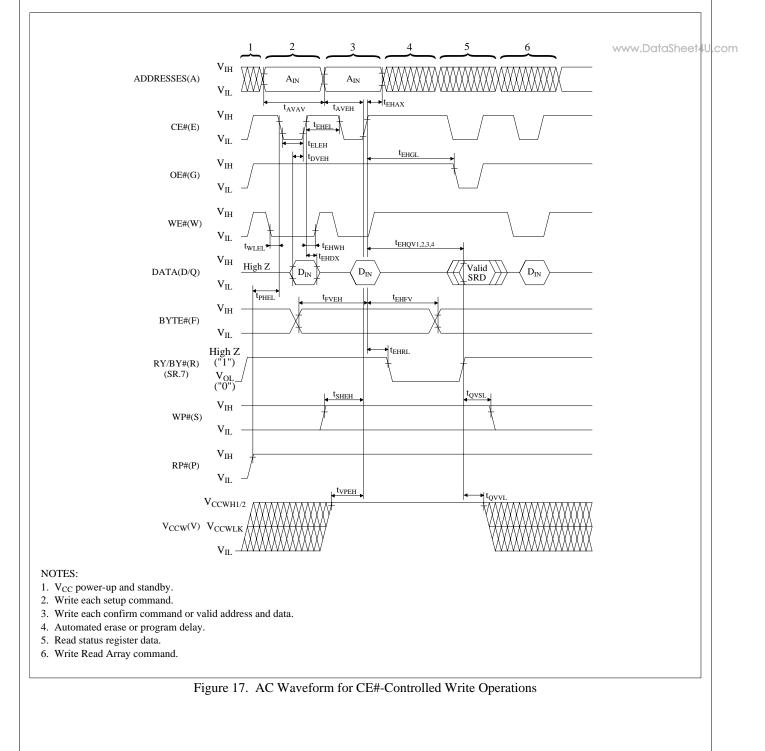
2. Sampled, not 100% tested.

Refer to Table 4 for valid A<sub>IN</sub> and D<sub>IN</sub> for block erase, full chip erase, word/byte write or lock-bit configuration.
 V<sub>CCW</sub> should be held at V<sub>CCWH1/2</sub> until determination of block erase, full chip erase, word/byte write or lock-bit configuration success (SR.1/3/4/5=0).

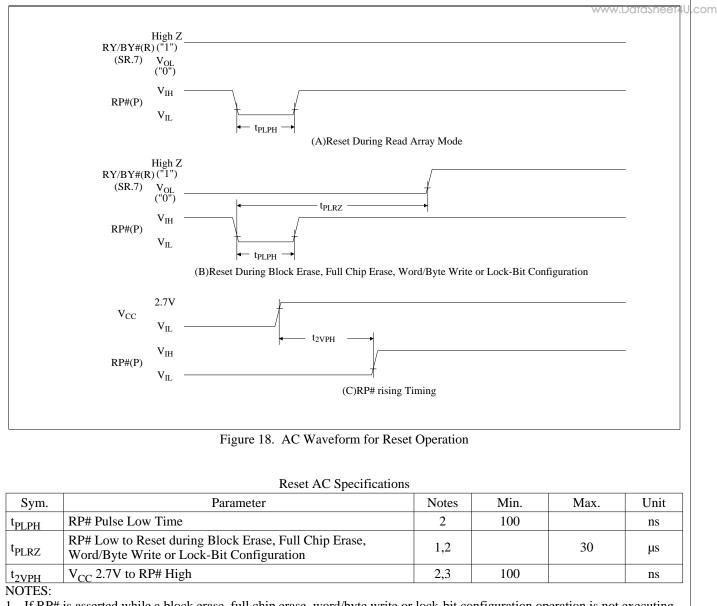
5. If BYTE# switch during reading cycle, exist the regulations separately.

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## 6.2.7 RESET OPERATIONS



1. If RP# is asserted while a block erase, full chip erase, word/byte write or lock-bit configuration operation is not executing, the reset will complete within 100ns.

A reset time, t<sub>PHQV</sub>, is required from the later of RY/BY#(SR.7) going High Z("1") or RP# going high until outputs are valid. Refer to AC Characteristics - Read-Only Operations for t<sub>PHQV</sub>.

3. When the device power-up, holding RP# low minimum 100ns is required after V<sub>CC</sub> has been in predefined range and also has been in stable there.

# 6.2.8 BLOCK ERASE, FULL CHIP ERASE, WORD/BYTE WRITE AND LOCK-BIT CONFIGURATION PERFORMANCE<sup>(3)</sup>

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		V <sub>CC</sub> =2.7V-2	3.6V, T <sub>A</sub> =	$=-40^{\circ}$ C to $+8$	5°C			
				V <sub>CCW</sub> =2.7V-3.6V		V <sub>CCW</sub> =11.7V-12.3V		
Sym.	Param	eter	Notes	Typ. <sup>(1)</sup>	Max.	Typ. <sup>(1)</sup>	Max.	Unit
t <sub>WHQV1</sub>	Word Write Time	32K word Block	2	33	200	20		μs
t <sub>EHQV1</sub>		4K word Block	2	36	200	27		μs
	Byte Write Time	64K byte Block	2	31	200	19		μs
		8K byte Block	2	32	200	26		μs
	Block Write Time	32K word Block	2	1.1	4	0.66		S
	(In word mode)	4K word Block	2	0.15	0.5	0.12		S
	Block Write Time	64K byte Block	2	2.2	7	1.4		S
	(In byte mode)	8K byte Block	2	0.3	1	0.25		S
t <sub>WHQV2</sub> t <sub>EHQV2</sub>	Block Erase Time	32K word Block 64K byte Block	2	1.2	6	0.9		S
		4K word Block 8K byte Block	2	0.6	5	0.5		S
	Full Chip Erase Time		2	42	210	32		S
t <sub>WHQV3</sub> t <sub>EHQV3</sub>	Set Lock-Bit Time		2	56	200	42		μs
t <sub>WHQV4</sub> t <sub>EHQV4</sub>	Clear Block Lock-Bits	Time	2	1	5	0.69		S
t <sub>WHRZ1</sub> t <sub>EHRZ1</sub>	Word/Byte Write Suspe Read	end Latency Time to	4	6	15	6	15	μs
t <sub>WHRZ2</sub> t <sub>EHRZ2</sub>	Block Erase Suspend L Read	atency Time to	4	16	30	16	30	μs

NOTES:

1. Typical values measured at  $T_A = +25^{\circ}C$  and  $V_{CC} = 3.0V$ ,  $V_{CCW} = 3.0V$  or 12.0V. Assumes corresponding lock-bits are not set. Subject to change based on device characterization.

2. Excludes system-level overhead.

3. Sampled but not 100% tested.

4. A latency time is required from issuing suspend command(WE# or CE# going high) until RY/BY# going High Z or SR.7 going "1".

7 Destroyer and realized model

### [Applicability]

This specification applies to IC package of the LEAD-FREE delivered as a standard specification.

- 1. Storage Conditions.
  - 1-1. Storage conditions required before opening the dry packing.
    - Normal temperature :  $5 \sim 40^{\circ}$ C
    - Normal humidity : 80%( Relative humidity) max.
      - \*"Humidity" means "Relative humidity"
  - 1-2. Storage conditions required after opening the dry packing.

In order to prevent moisture absorption after opening, ensure the following storage conditions apply:

- Storage conditions for one-time soldering. (Convection reflow<sup>\*1</sup>, IR/Convection reflow.<sup>\*1</sup>, or Manual soldering.)
  - Temperature : 5∼25℃
  - Humidity : 60% max.
  - Period : 72 hours max. after opening.
- (2) Storage conditions for two-time soldering. (Convection reflow.<sup>\*1</sup>, IR/Convection reflow.<sup>\*1</sup>)
  - a. Storage conditions following opening and prior to performing the 1st reflow.
  - Temperature :  $5 \sim 25^{\circ}$ C
  - Humidity : 60% max.
  - Period : 72 hours max. after opening.
  - b. Storage conditions following completion of the 1st reflow and prior to performing the 2nd reflow.
  - Temperature : 5∼25℃
  - Humidity : 60% max.
  - Period : 72 hours max. after completion of the 1st reflow.
- <sup>\*1</sup>:Air or nitrogen environment.

#### 1-3. Temporary storage after opening.

To re-store the devices before soldering, do so only once and use a dry box or place desiccant (with a blue humidity indicator) with the devices and perform dry packing again using heat-sealing.

- The storage period, temperature and humidity must be as follows :
- (1) Storage temperature and humidity.
  - $\times 1$ : External atmosphere temperature and humidity of the dry packing.

First opening	x ← x1 − R	le sealing ← Y	► Re-opening ← X2 —	→ Mounting
				Q
%1 Temperature ∶ 5~40°C	$5\sim 25^{\circ}$ C	<b>※</b> 1 5~40℃	¦ 5∼25℃	l F
Humidity : 80% max.	60% max.	80% max.	60% max.	
		i	1	

#### (2) Storage period.

1-2(1) and (2)a, depending on the mounting method.

٠Y

: Two weeks max.



- 2. Baking Condition.
  - (1) Situations requiring baking before mounting.
    - Storage conditions exceed the limits specified in Section 1-2 or 1-3.
    - · Humidity indicator in the desiccant was already red (pink) when opened.
      - ( Also for re-opening.)
  - (2) Recommended baking conditions.
    - Baking temperature and period :

 $120^{\circ}$ C for  $16 \sim 24$  hours.

- The above baking conditions apply since the trays are heat-resistant.
- (3) Storage after baking.
  - After baking, store the devices in the environment specified in Section 1-2 and mount immediately.
- 3. Surface mount conditions.

The following soldering condition are recommended to ensure device quality.

- 3-1.Soldering.
- (1) Convection reflow or IR/Convection. (one-time soldering or two-time soldering in air or nitrogen environment)
  - Temperature and period :
    - A) Peak temperature.
    - B) Heating temperature.
    - C) Preheat temperature.
    - D) Temperature increase rate.
  - Measuring point : IC package surface.
  - · Temperature profile:

- 250°C max. 40 to 60 seconds as 220°C It is 150 to 200°C, and is 120±30 seconds It is 1 to 3°C/seconds
- A B C backage surface temperature D D D

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- (2) Manual soldering ( soldering iron ) ( one-time soldering only ) Soldering iron should only touch the IC's outer leads.
  - Temperature and period :
    - 350°C max. for 3 seconds / pin max.
    - (Soldering iron should only touch the IC's outer leads.)
  - Measuring point : Soldering iron tip.
- 4. Condition for removal of residual flux.
  - (1) Ultrasonic washing power : 25 watts / liter max.
  - (2) Washing time : Total 1 minute max.
  - (3) Solvent temperature :  $15 \sim 40^{\circ}$ C

5. Package outline specification.

Refer to the attached drawing.

(Plastic body dimensions do not include burr of resin.)

The contents of LEAD-FREE TYPE application of the specifications. (\*2)

#### 6. Markings.

6-1. Marking details. (The information on the package should be given as follows.)

- (1) Product name : LH28F160BJHE-BTLTH (2) Company name SHARP : (3) Date code (Example) YYWW XXX : YY  $\rightarrow$ Denotes the production year. (Last two digits of the year.) Denotes the production week.  $(01 \cdot 02 \cdot \sim \cdot 52 \cdot 53)$ WW  $\rightarrow$ XXX  $\rightarrow$ Denotes the production ref. code ( $1 \sim 3$  digits).
- (4) "JAPAN" indicates the country of origin.

6-2.Marking layout.

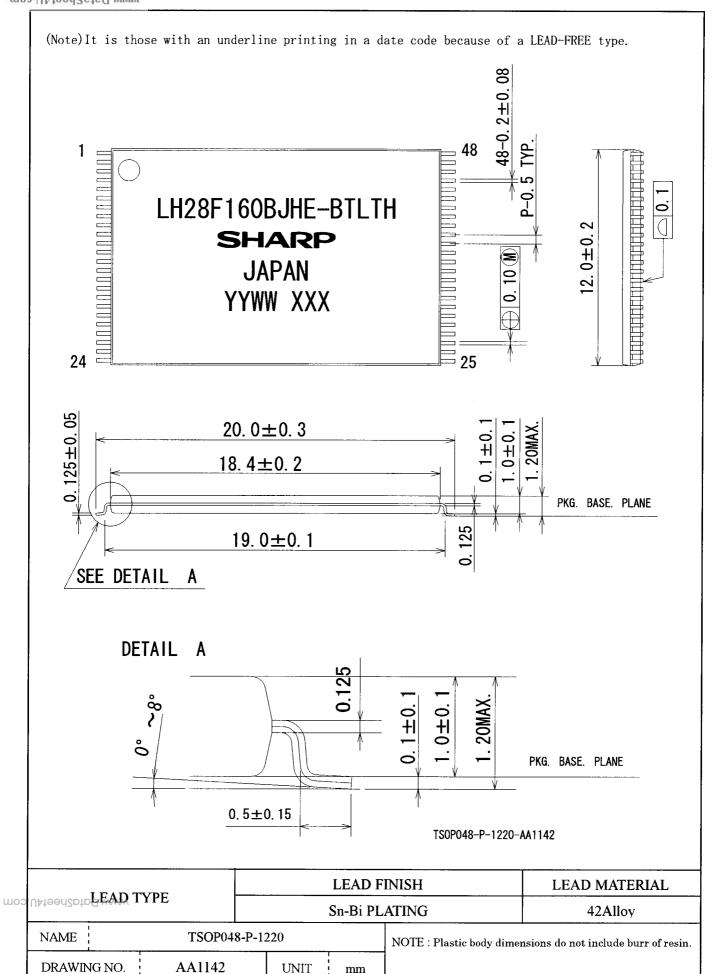
The layout is shown in the attached drawing.

(However, this layout does not specify the size of the marking character and marking position.)

LEAD FINISH or BALL TYPE	LEAD-FREE TYPE (Sn-Bi)		
DATE CODE	They are those with an underline.		
The word of "LEAD FREE" is printed on the packing label	Printed		

#### \*2 The contents of LEAD-FREE TYPE application of the specifications.





## 7.Packing Specifications (Dry packing for surface mount packages.)

#### 7-1.Packing materials.

Material name Material specifications		Purpose		
Inner carton	Cardboard (960 devices / inner carton	Packing the devices.		
	max.)	(10 trays / inner carton)		
Tray	Conductive plastic (96 devices / tray)	Securing the devices.		
Upper cover tray	Conductive plastic (1 tray / inner carton)	Securing the devices.		
Laminated aluminum Aluminum polyethylene		Keeping the devices dry.		
bag				
Desiccant	Silica gel	Keeping the devices dry.		
Label	Paper	Indicates part number,		
		quantity, and packed date.		
PP band	Polypropylene (3 pcs. / inner carton)	Securing the devices.		
Outer carton	Cardboard (3840 devices / outer carton	Outer packing.		
	max.)			

( Devices must be placed on the tray in the same direction.)

7-2.Outline dimension of tray.

Refer to the attached drawing.

7-3.Outline dimension of carton.

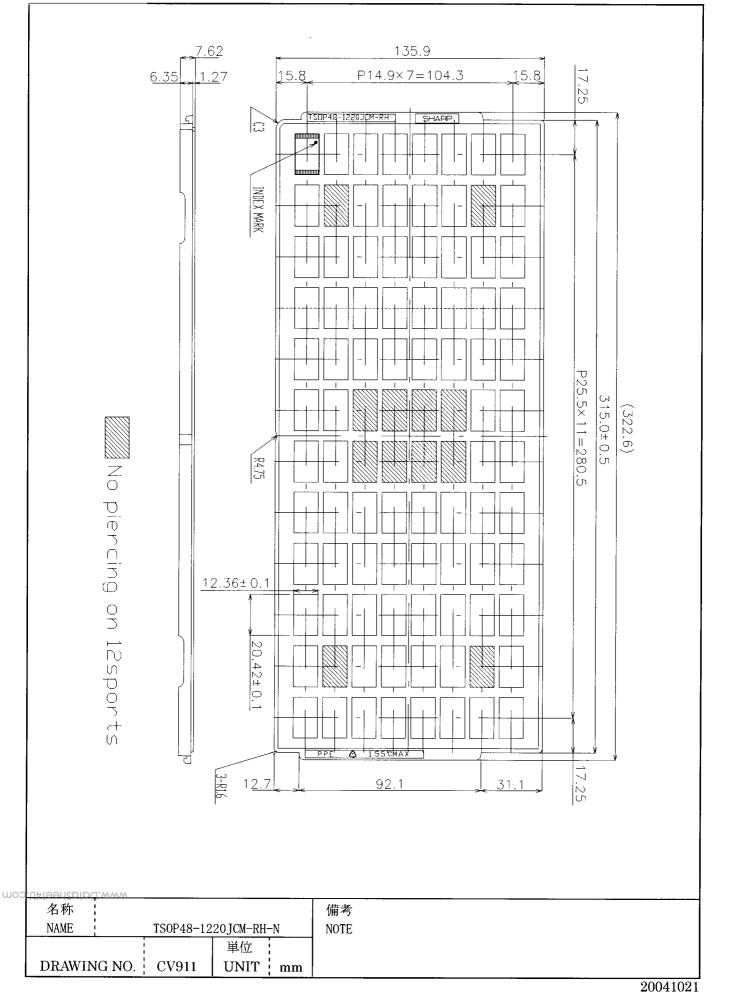
Refer to the attached drawing.

8. Precautions for use.

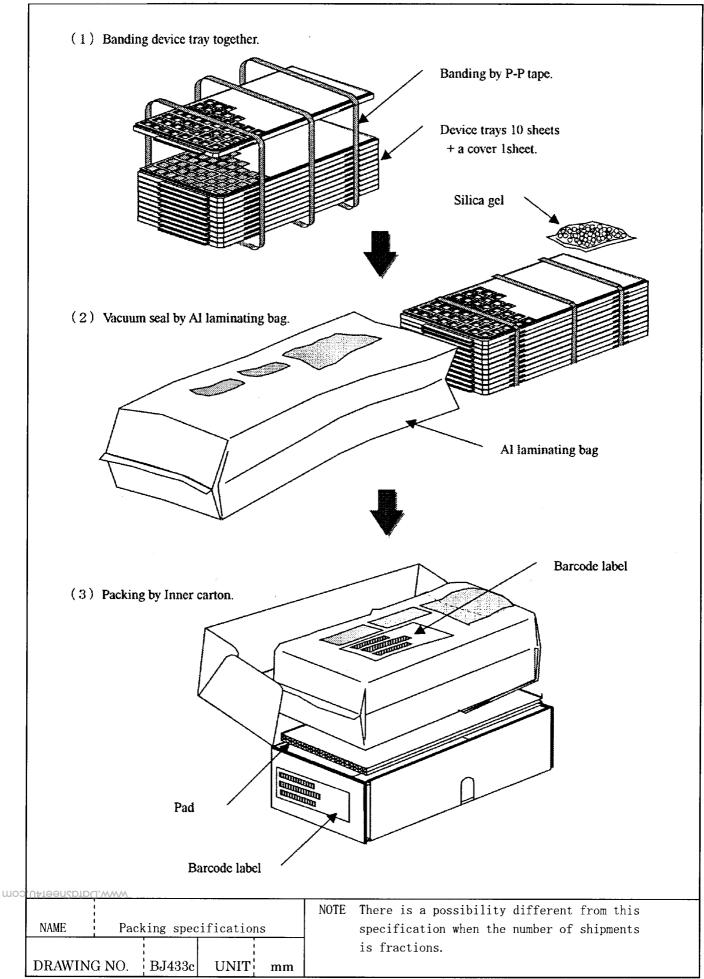
- (1) Opening must be done on an anti-ESD treated workbench. All workers must also have undergone anti-ESD treatment.
- (2) The trays have undergone either conductive or anti-ESD treatment. If another tray is used, make sure it has also undergone conductive or anti-ESD treatment.
- (3) The devices should be mounted within one year of the date of delivery.



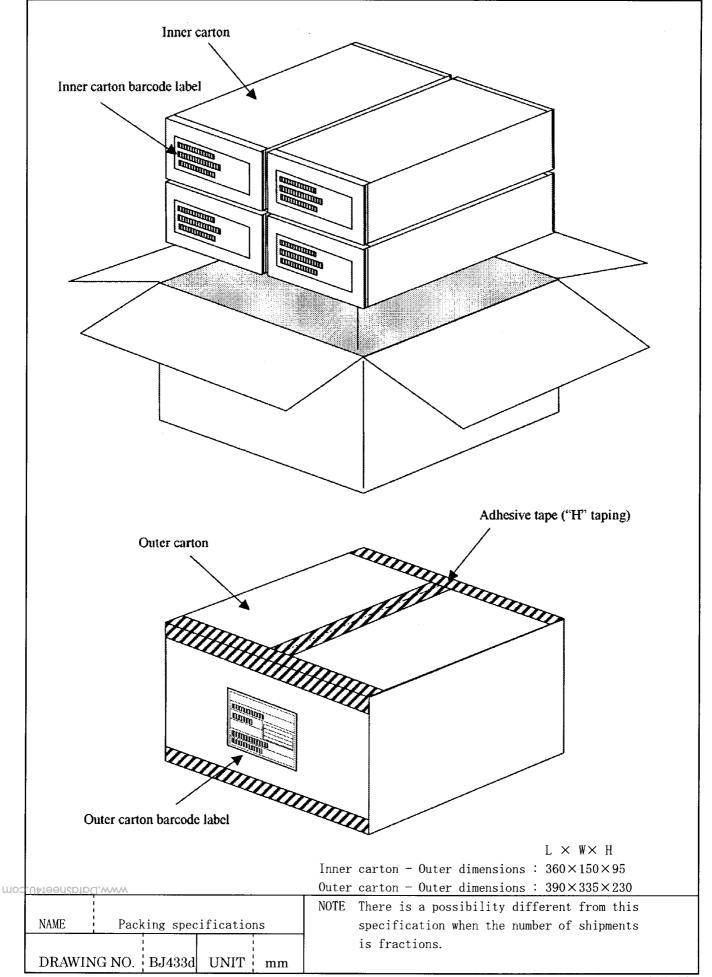




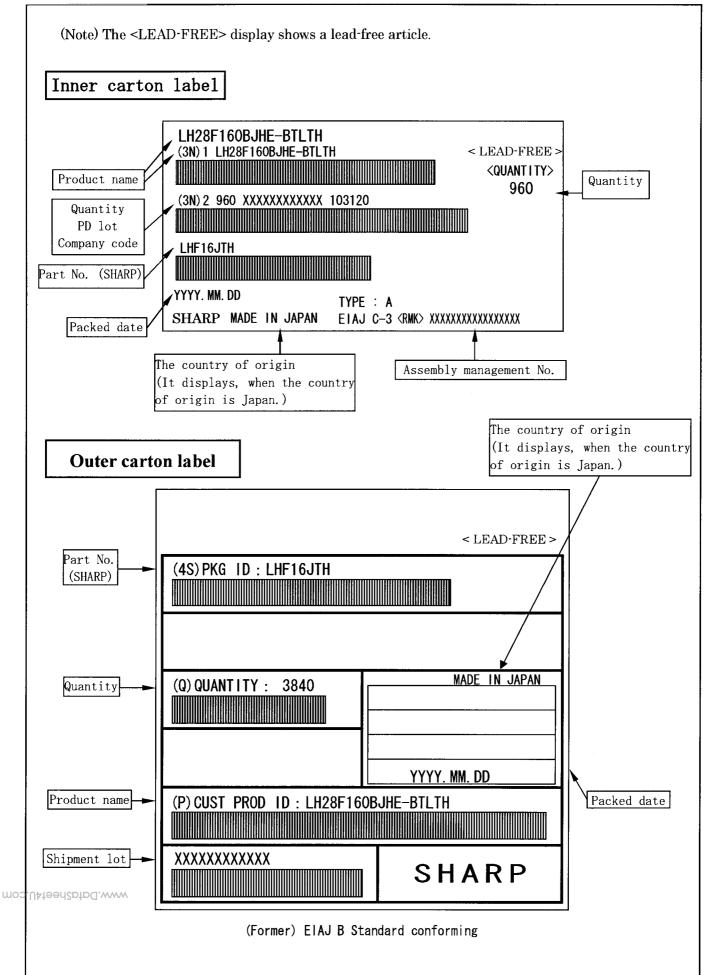














### **ADDITIONAL INFORMATION**

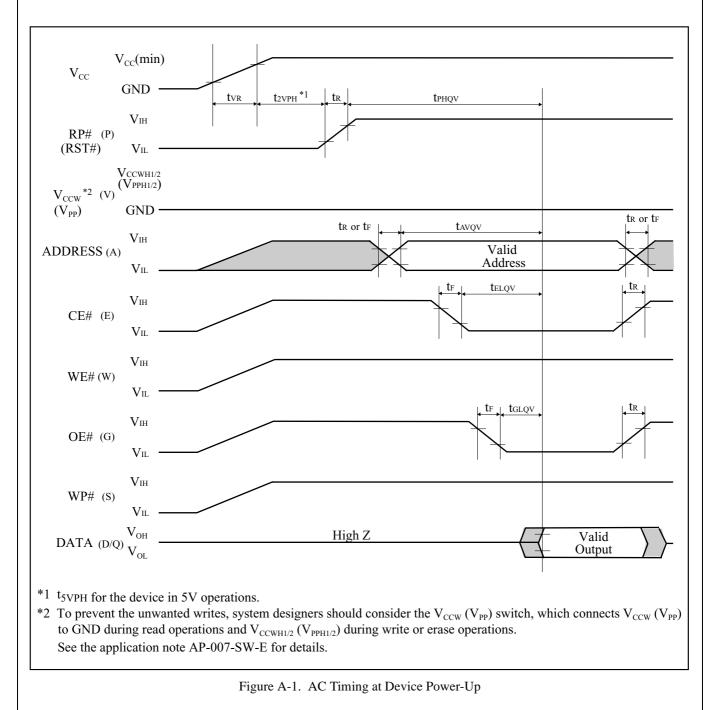
## 1 Block Erase Suspend and Resume command

If the time between writing the Block Erase Resume command and writing the Block Erase Suspend command is shorter than 15ms and both commands are written repeatedly, a longer time is required than standard block erase until the completion of the operation.

## A-1 RECOMMENDED OPERATING CONDITIONS

### A-1.1 At Device Power-Up

AC timing illustrated in Figure A-1 is recommended for the supply voltages and the control signals at device power-up. If the timing in the figure is ignored, the device may not operate correctly.



For the AC specifications  $t_{VR}$ ,  $t_R$ ,  $t_F$  in the figure, refer to the next page. See the "ELECTRICAL SPECIFICATIONS" described in specifications for the supply voltage range, the operating temperature and the AC specifications not shown in the next page.

## A-1.1.1 Rise and Fall Time

Symbol	Parameter	Notes	Min.	Max.	Unit
t <sub>VR</sub>	V <sub>CC</sub> Rise Time	1	0.5	30000	μs/V
t <sub>R</sub>	Input Signal Rise Time			1	μs/V
t <sub>F</sub>	Input Signal Fall Time	1, 2		1	μs/V

NOTES:

1. Sampled, not 100% tested.

2. This specification is applied for not only the device power-up but also the normal operations.  $t_R(Max.)$  and  $t_F(Max.)$  for RP# (RST#) are 50µs/V.



### A-1.2 Glitch Noises

Do not input the glitch noises which are below  $V_{IH}$  (Min.) or above  $V_{IL}$  (Max.) on address, data, reset, and control signals, as shown in Figure A-2 (b). The acceptable glitch noises are illustrated in Figure A-2 (a).

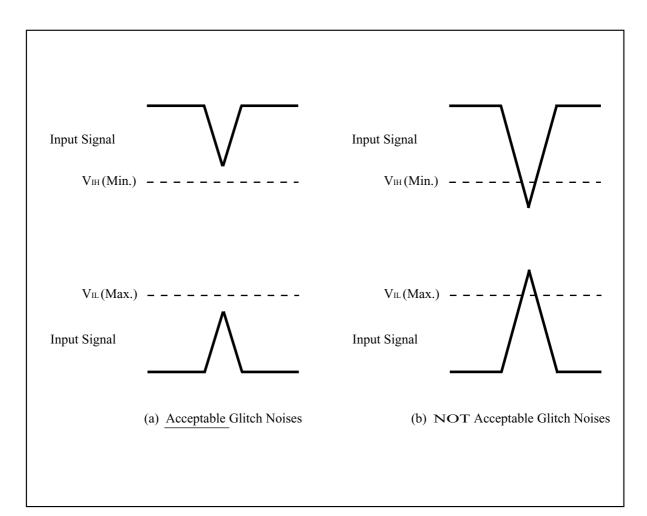


Figure A-2. Waveform for Glitch Noises

See the "DC CHARACTERISTICS" described in specifications for  $V_{IH}$  (Min.) and  $V_{IL}$  (Max.).

## A-2 RELATED DOCUMENT INFORMATION<sup>(1)</sup>

Document No.	Document Name
AP-001-SD-E	Flash Memory Family Software Drivers
АР-006-РТ-Е	Data Protection Method of SHARP Flash Memory
AP-007-SW-E RP#, V <sub>PP</sub> Electric Potential Switching Circuit	

NOTE:

1. International customers should contact their local SHARP or distribution sales office.

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